

RESONANT SOFT X-RAY SCATTERING ON

LiCu_3O_3



OUTLINE

- I. Introduction
- II. Presenting raw data from the experiment
- III. Fitting the data for each energy
- IV. Unexpected feature in the data
- V. Extracting physical quantities form the data
- VI. Kramers-Kronig Analysis
- VII. Total Electron Yield
- VIII. Magnetic Dichorism
- IX. Optical Conductivity



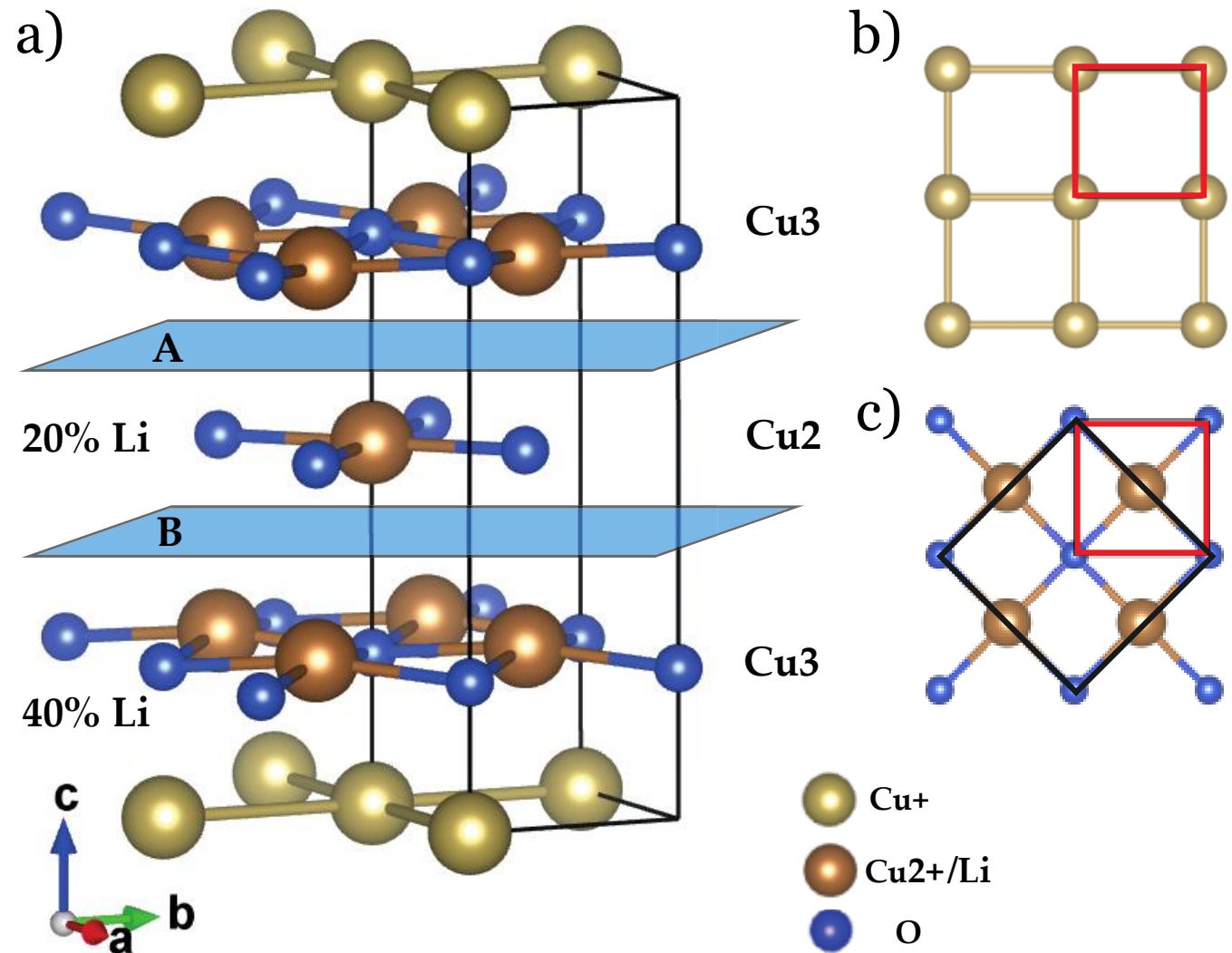
I. Introduction:

1. Material characterization
2. Theoretical Introduction
3. Experimental geometry



LiCu_3O_3

- Trilayers of rocksalt $\text{Cu}(\text{II})\text{O}$ are sandwiched between planes of $\text{Cu}(\text{I})$
- The Lithium randomly substitutes the $\text{Cu}(\text{II})$ ions
- Lattice: tetragonal crystal structure ($\text{P}4/\text{mmm}$, $a = 2.81 \text{ \AA}$, $c = 8.90 \text{ \AA}$)

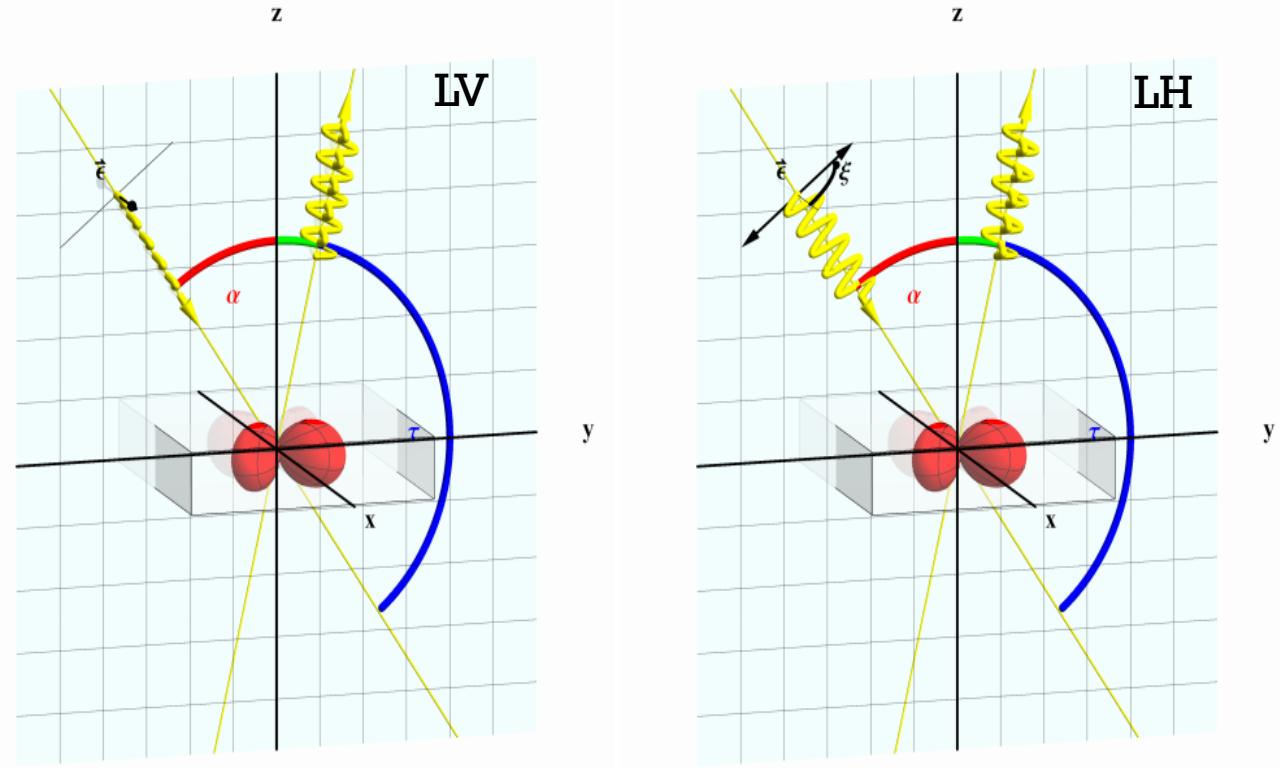


THEORETICAL INTRODUCTION



EXPERIMENTAL GEOMETRY

The polarisation geometry was chosen the same as in Moser [5], thus the scattering plane lies in the yz plane (as shown in the figure for in-plane (LH) and out of plane (LV) polarization).

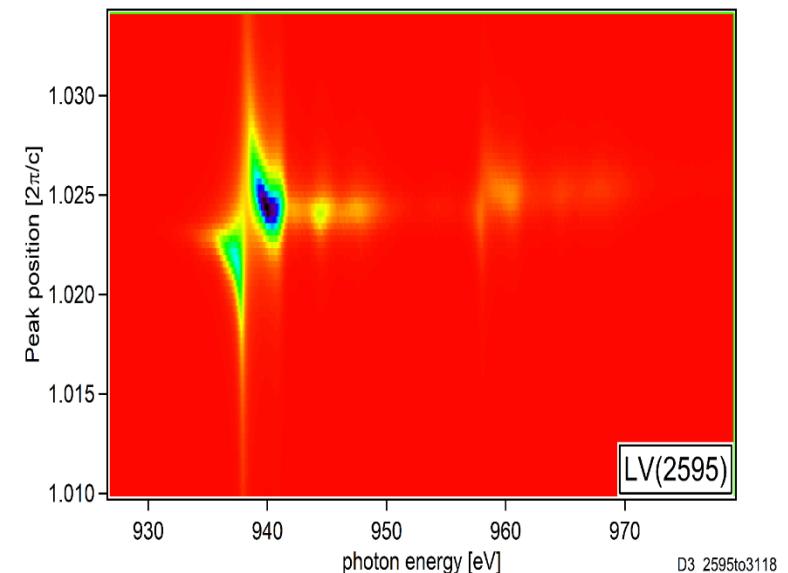
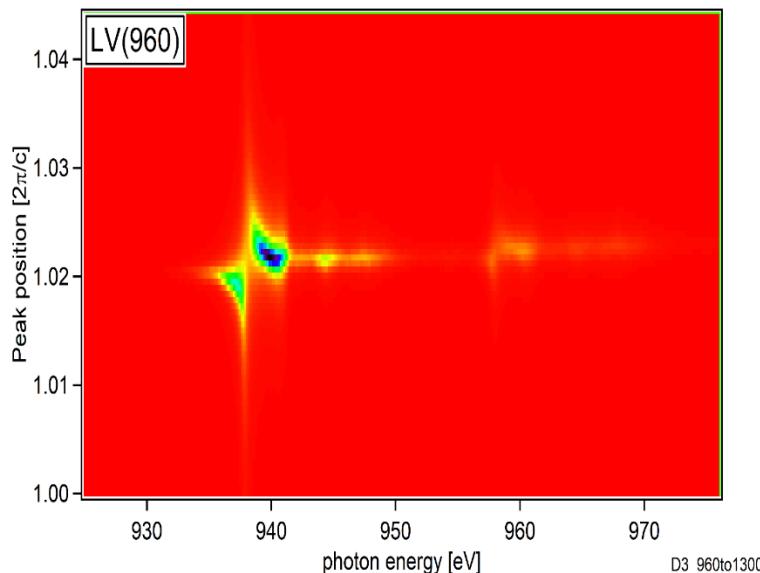
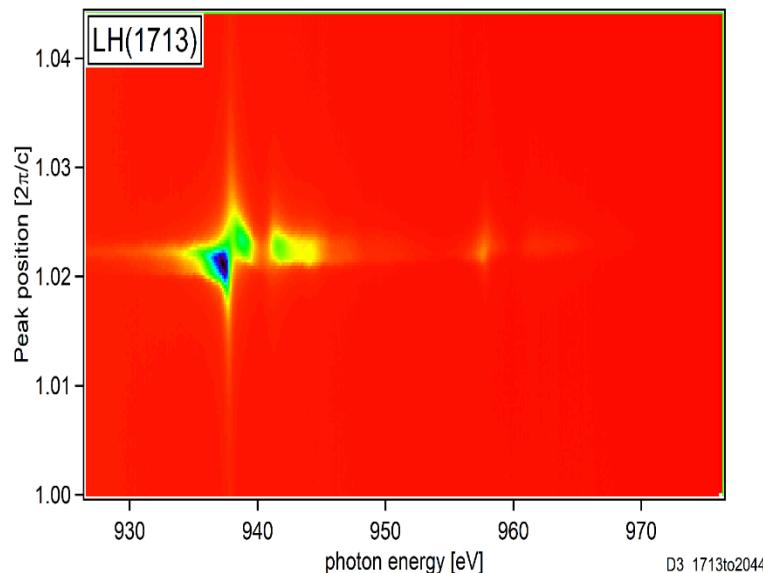
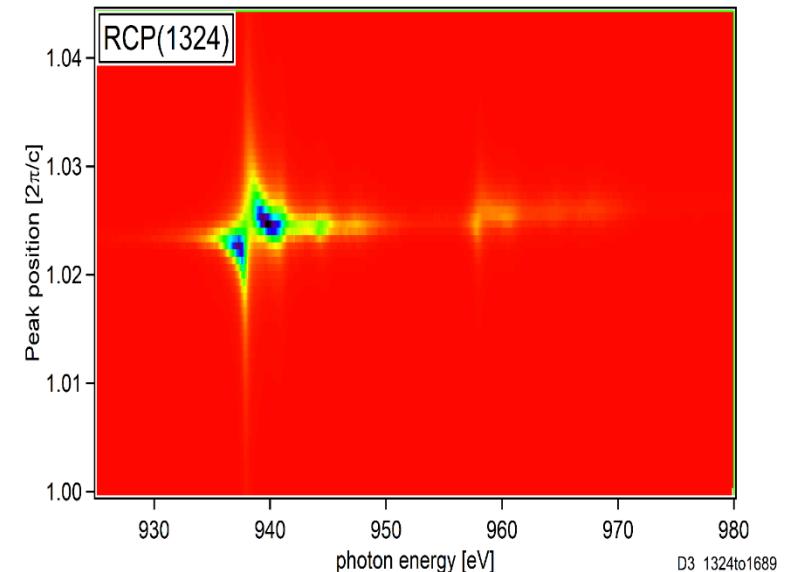
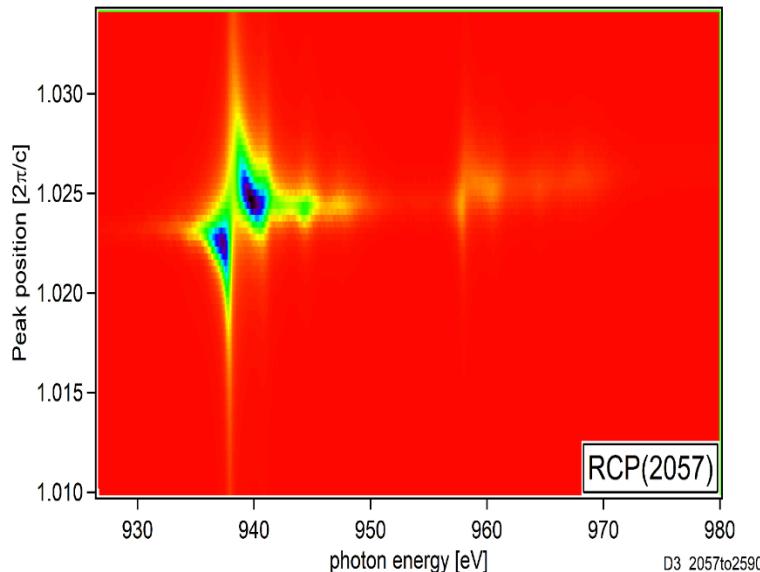
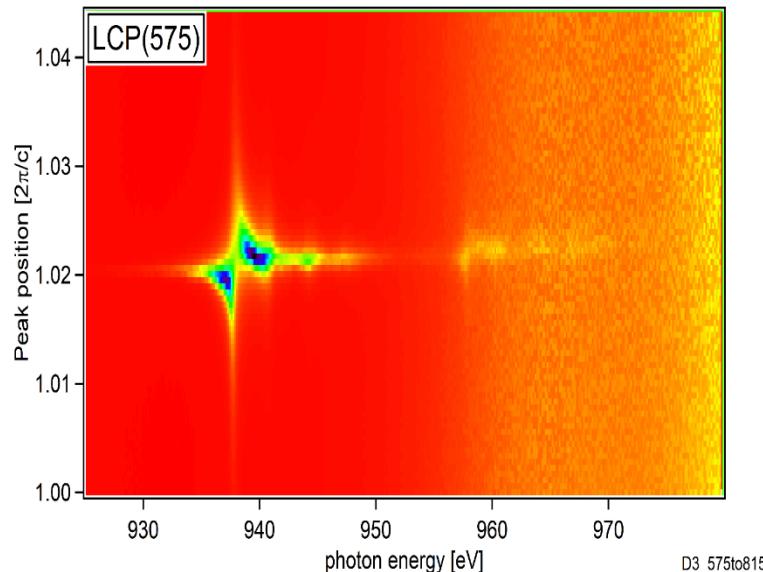


II. Presenting raw data from the experiment:

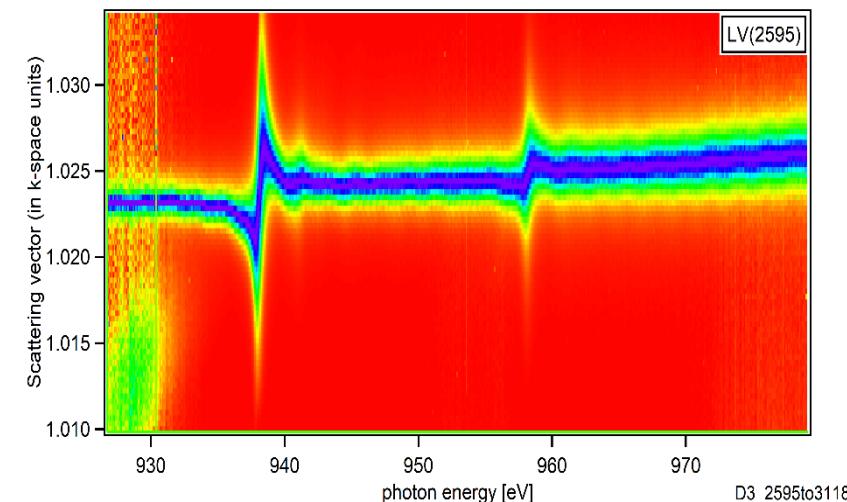
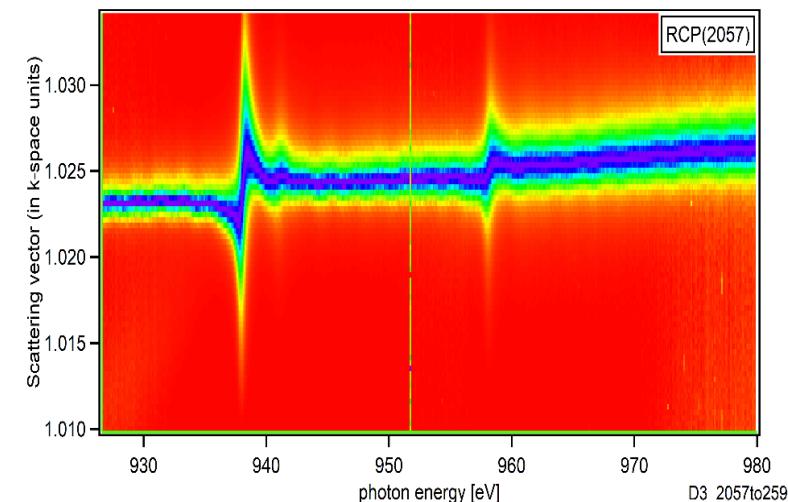
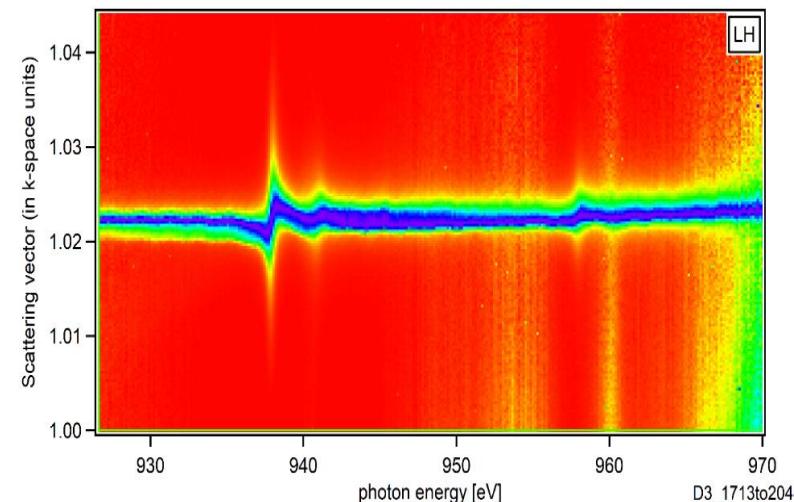
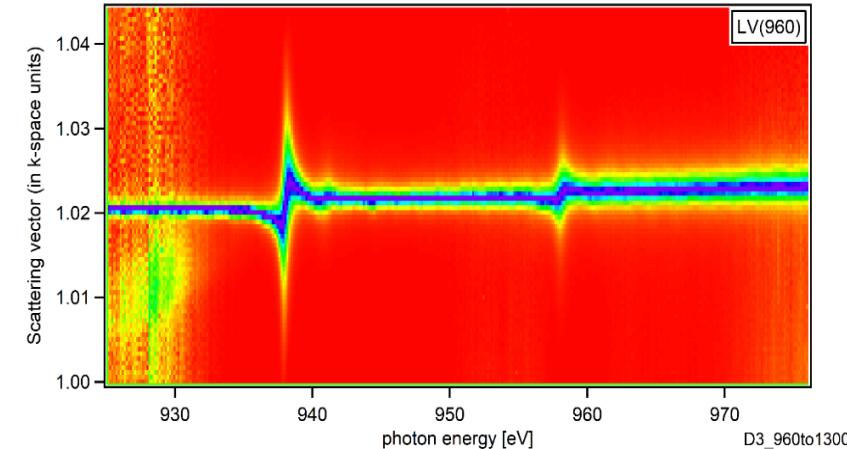
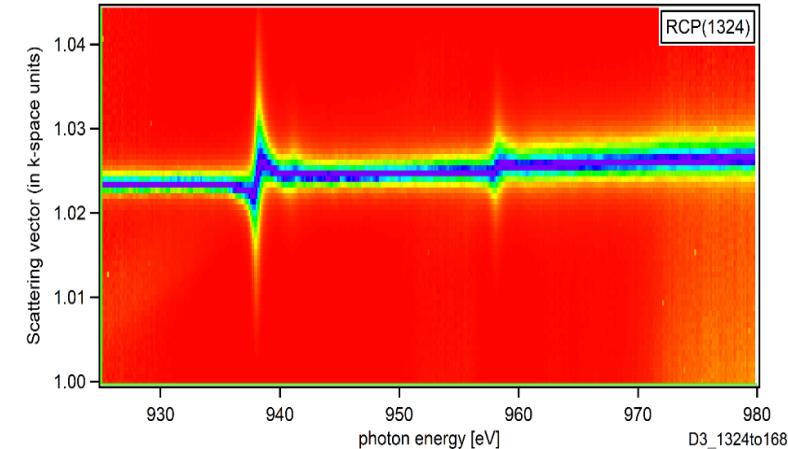
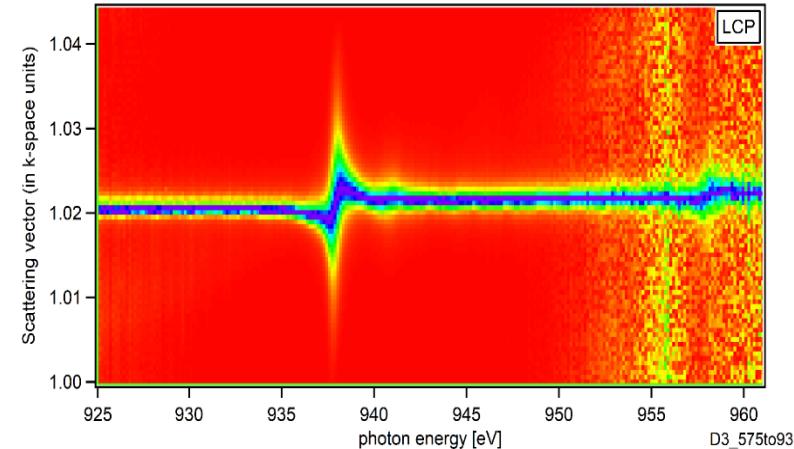
- 1. Raw data**
- 2. Normalizing raw data**
- 3. Quick analysis**



RAW RSXS DATA



RSXS RESULTS – NORMALIZED BY $\frac{-I_{min}(\theta)}{I_{max}(\theta)-I_{min}(\theta)}$



RAW DATA ANALYSIS

- Strong intensity enhancement at copper L edges
- Peak position looks like real part of dielectric function
- Broadening of peak width along the energy axis (connected to increased absorption)
- Linear dichroic effects shown for linear polarizations: difference in maximum intensity for LV and LH polarization (LH has stronger intensity right before $Cu^{2+} L_3$ edge, but LV has maximum peak after $Cu^{2+} L_3$)



III. Fitting raw data for each energy:

- 1. Comparing gaussian and lorentzian fit**
- 2. Fitting the experimental data**



FITTING RAW DATA

Fitting experimental data with:

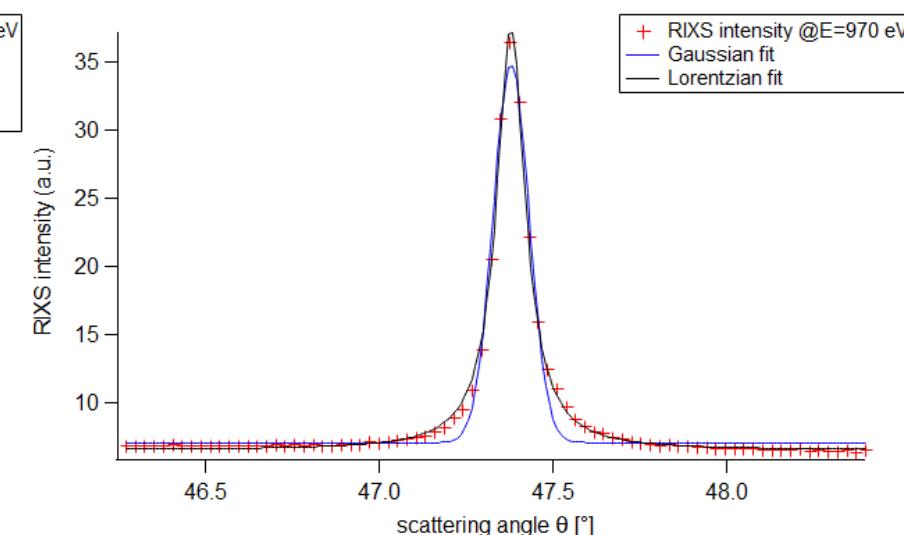
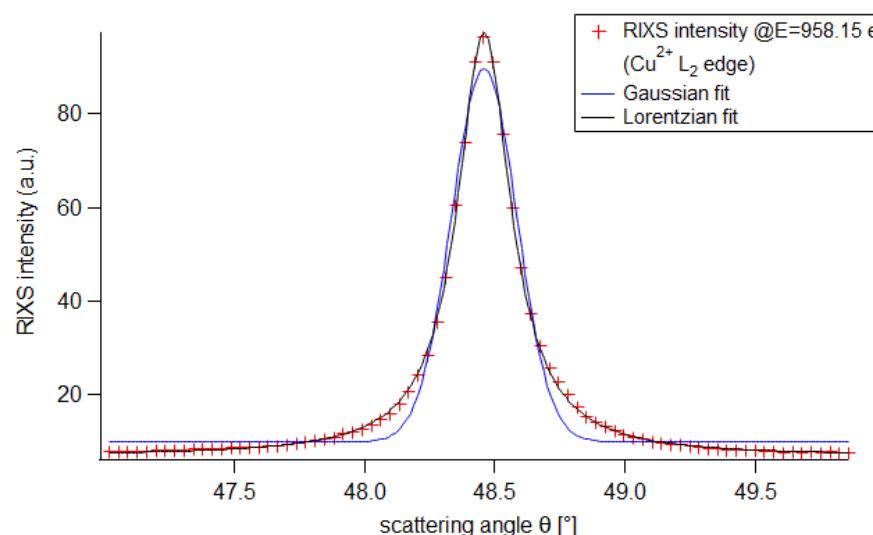
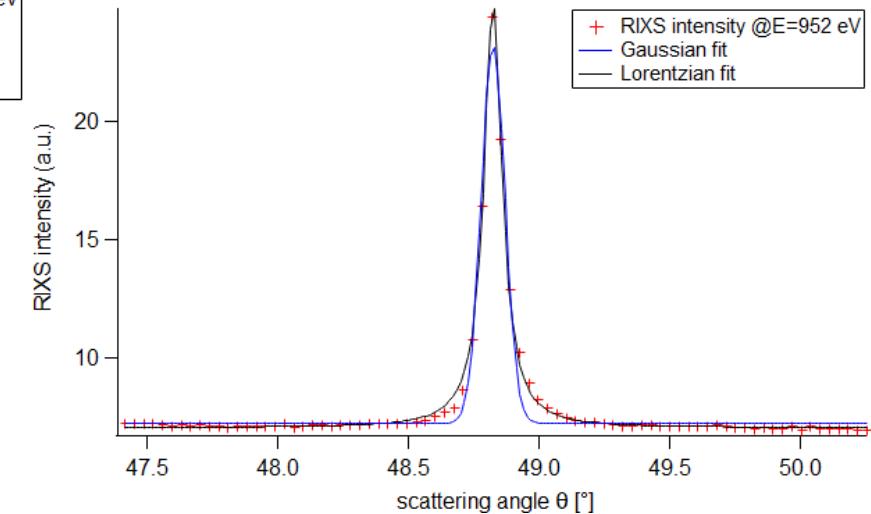
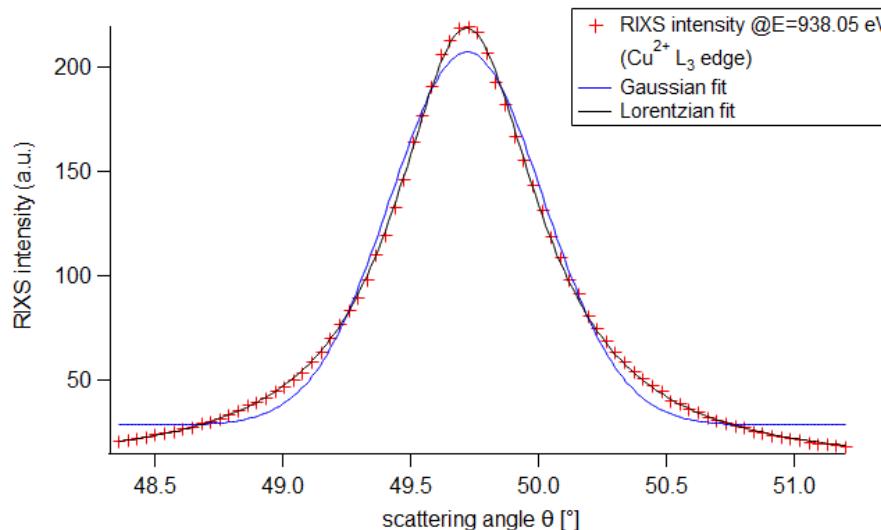
$$f_{Gauss}(x) = y_0 + A \exp\left(-\left(\frac{x-x_0}{B}\right)^2\right)$$

and

$$f_{Lorentz}(x) = y_0 + \frac{A}{(x - x_0)^2 + B}$$

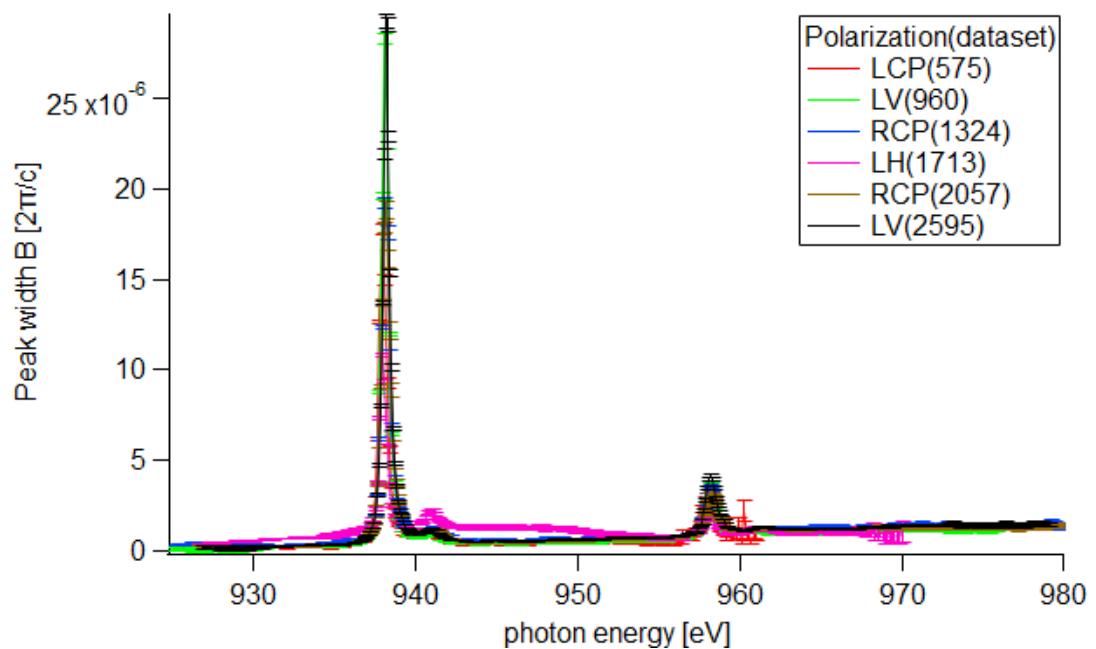
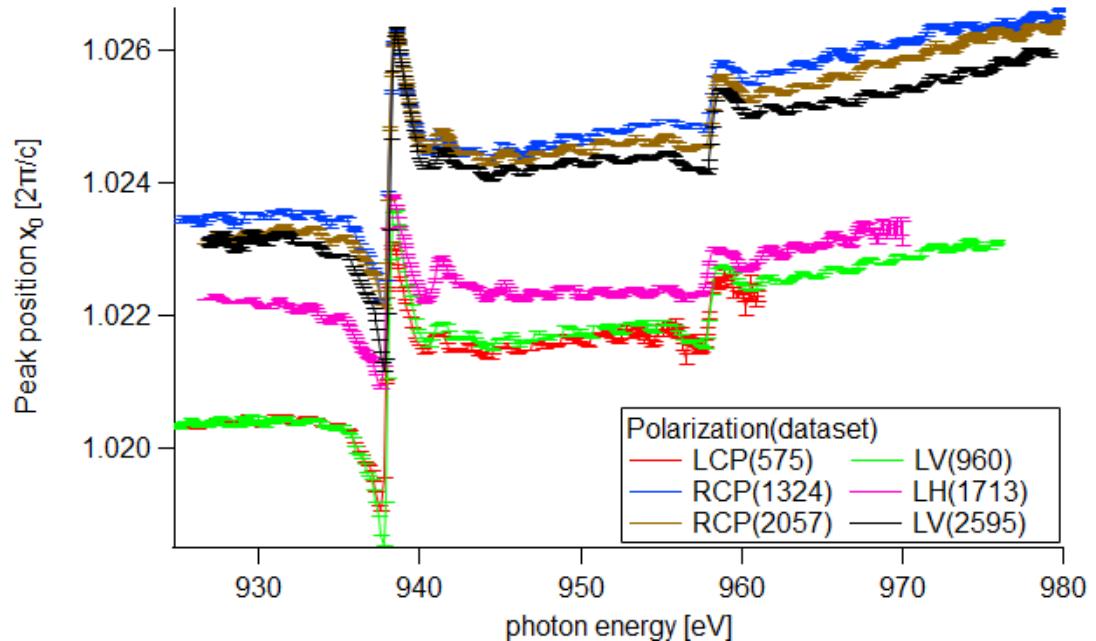
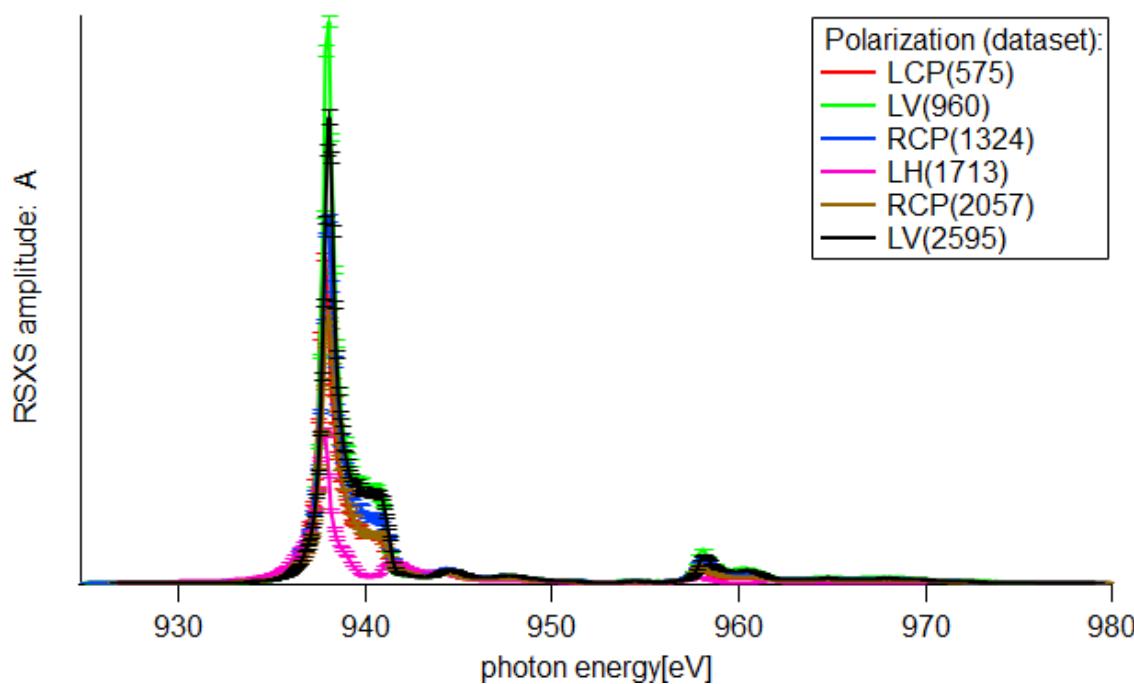
The loretzian one shows better agreement with experimental data.

Fitted raw data for LV(960) polarization



FITTING RAW DATA

- Fit every lineshape for every energy and each polarisation.
FWHM of this function is $2\sqrt{B}$.



IV. Unexpected feature in the data:

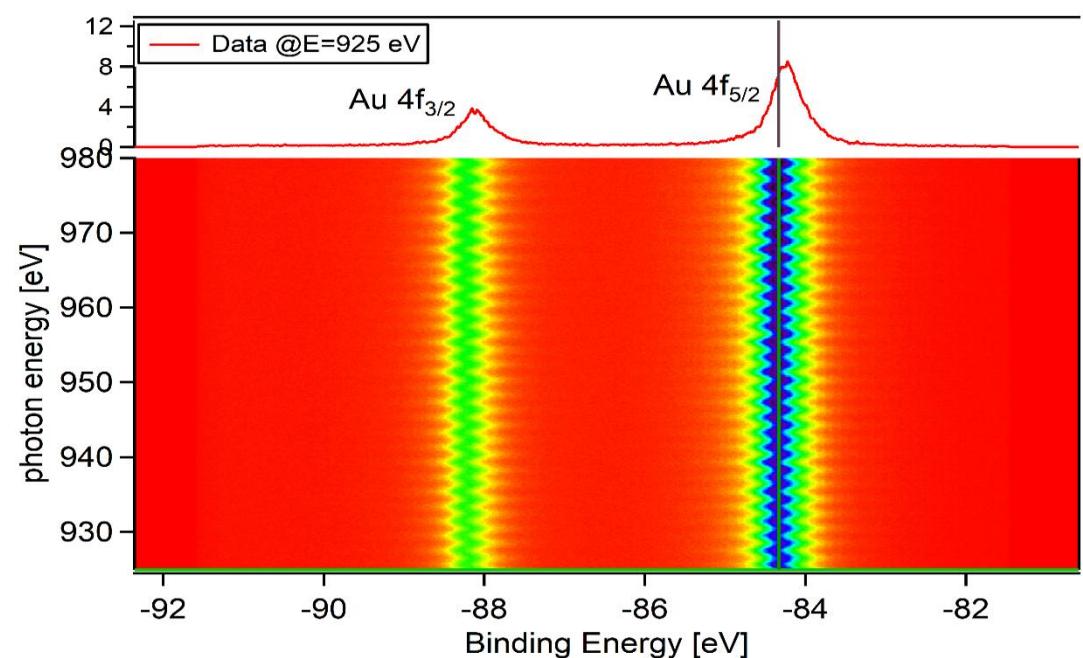
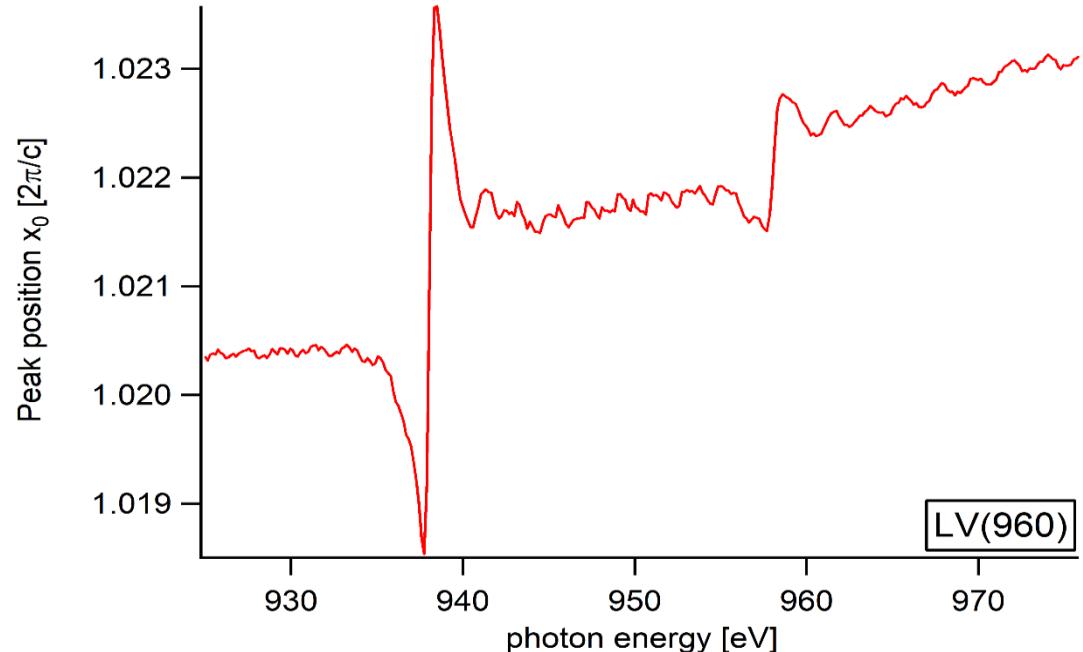
- 1. Describing problem**
- 2. Suggested solution**
- 3. Using χ^2 minimalization**
- 4. Calculated χ^2 for various polarizations**
- 5. Results**



DESCRIBING PROBLEM

What we see in the fitted data is the peak position exhibits oscillating behaviour. The most probable cause of this is a problem with the monochromator, which gives slightly shifted energies. It is important to note that such behaviour is not present in the other fit parameters. This means one needs to find an effective way to remove those unrealistic oscillating feature.

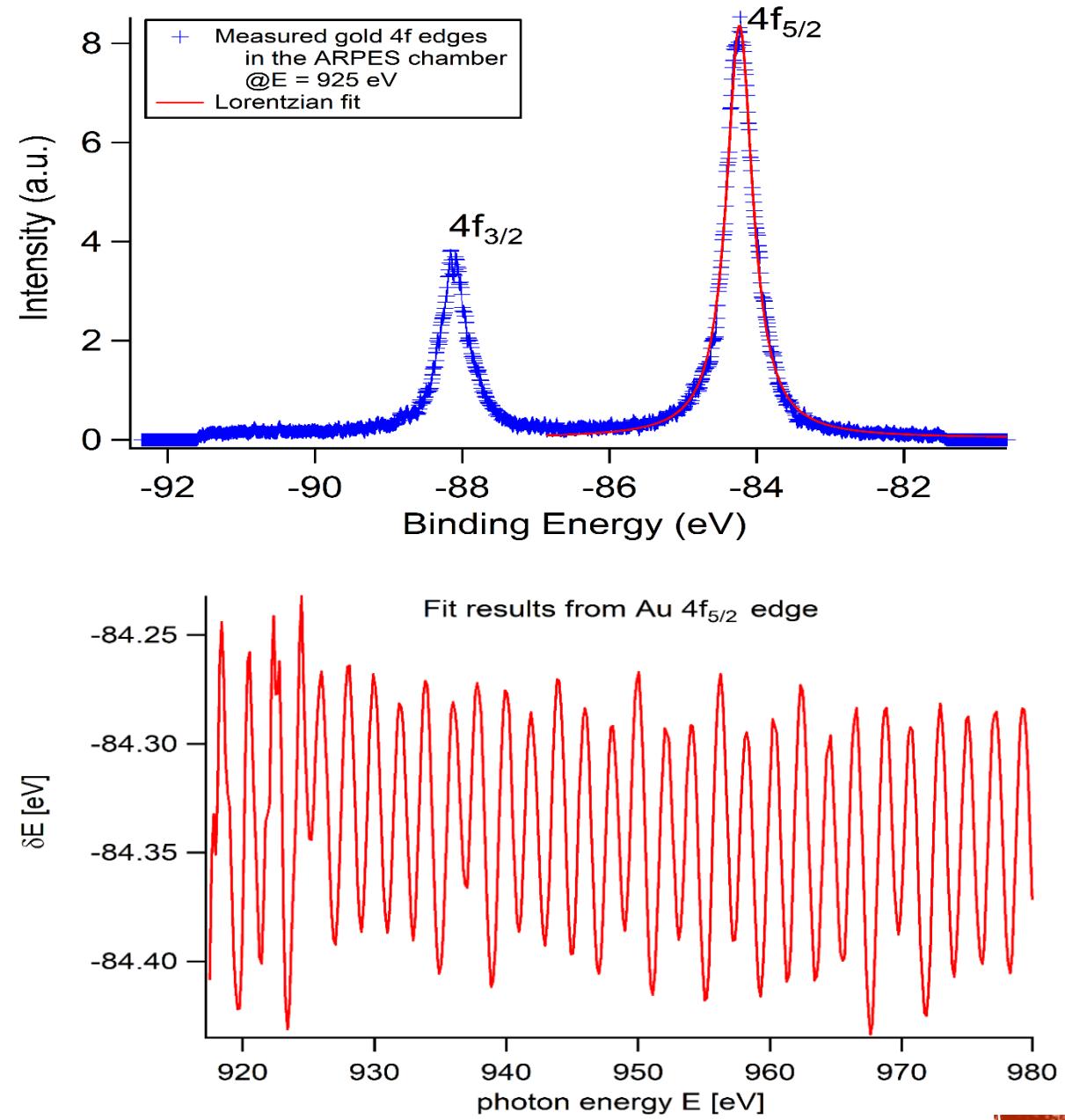
In the later a χ^2 test is described as a solution to this problem.



SOLUTION

At the same beamline in the ARPES chamber was an experiment on gold performed for the same set of photon energies as for the RSXS experiment. The results shown on the right side show the same feature as the position of the Bragg peak in the RSXS data.

Fitting on of the gold 4f edges with a lorentzian shape gives us the detailed information how this oscillation depended on the energy. Using this fit results one can subtract the oscillation in the peak position. To match the fitted oscillations with the one present in the peak position we need to consider an offset in the energy. To find the proper offset a χ^2 minimalization procedure is used.



USING χ^2 MINIMIZATION

From the gold 4f edge we find the desired oscillations in relative energy units, but to use them in the χ^2 test we need to change them in relative peak position using the formula:

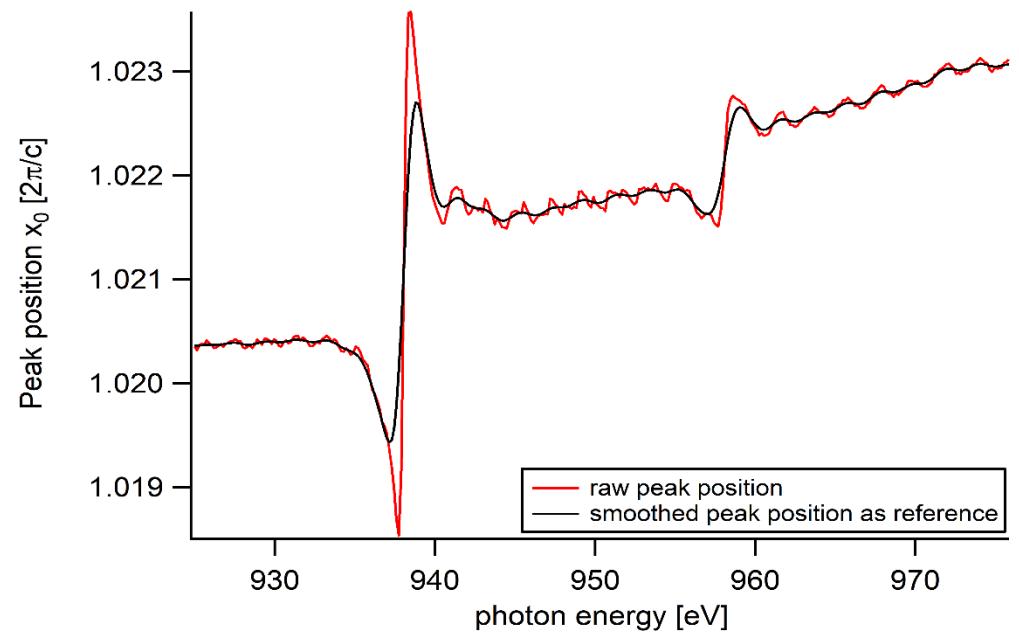
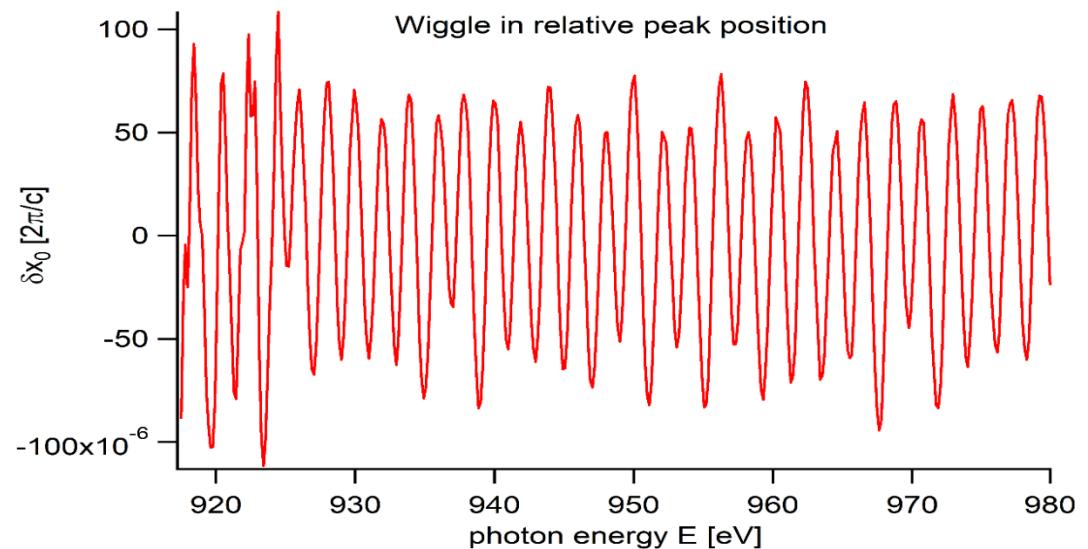
$$\delta x_0 = \frac{\partial x_0}{\partial E} \delta E = \frac{2d}{hc} \sin(\theta) \delta E$$

Moreover we need to set an offset to the result to have the oscillations around zero. The resulting oscillations are show in the fugre on the right-top.

For the use of the χ^2 test we need a reference of the peak position. A smoothed peak position was chosen, as shown in the graph on the right. Although the smoothed function decreases the peak position in the range of the resonance rather strongly, it is done symmetrically, which means that it only rises a constant value in the calculated χ^2 , which is done by the formula [1]:

$$\chi^2(\Delta E) = \sum_E \frac{(x_0(E) - \delta x_0(E + \Delta E) - x_0^{ref}(E))^2}{\sigma[x_0(E)]},$$

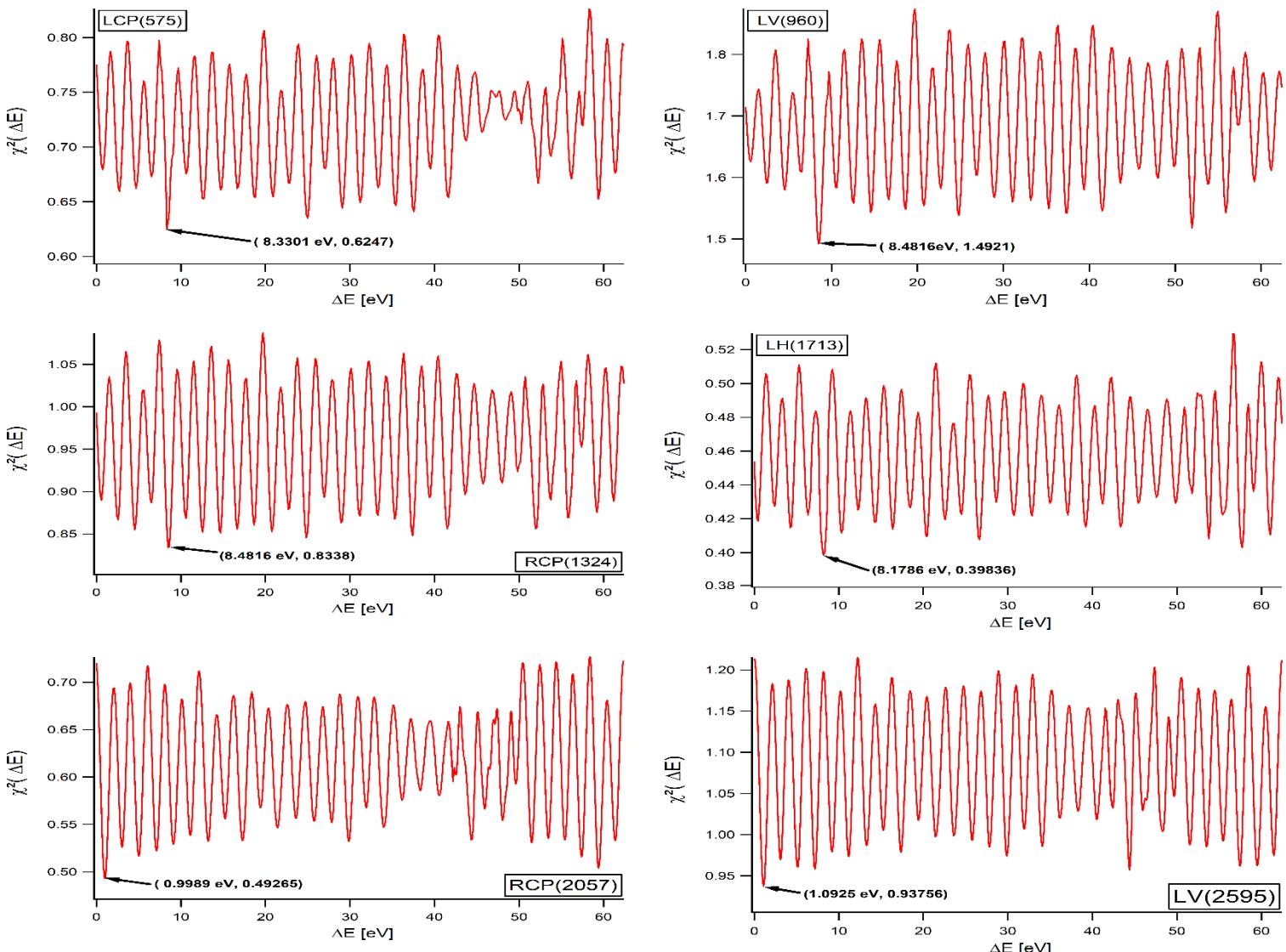
where x_0^{ref} is the reference peak position (obtained by the smoothing) and $\sigma(x_0)$ is the deviation of the peak position from the fit procedure of the raw data.



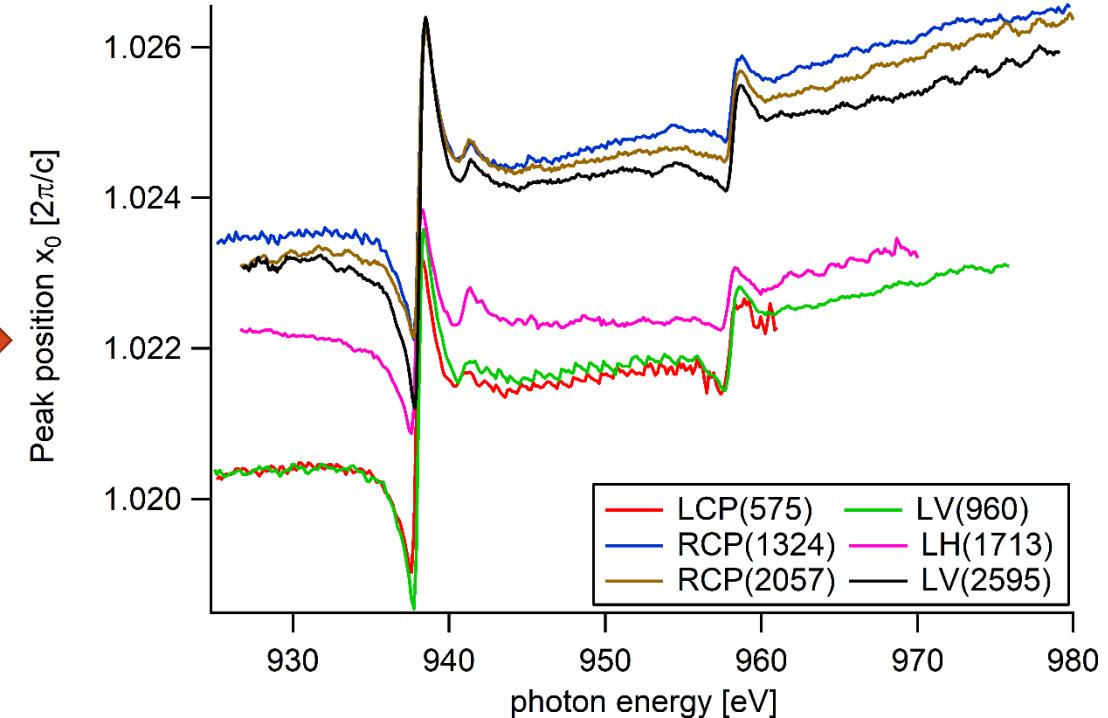
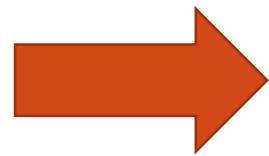
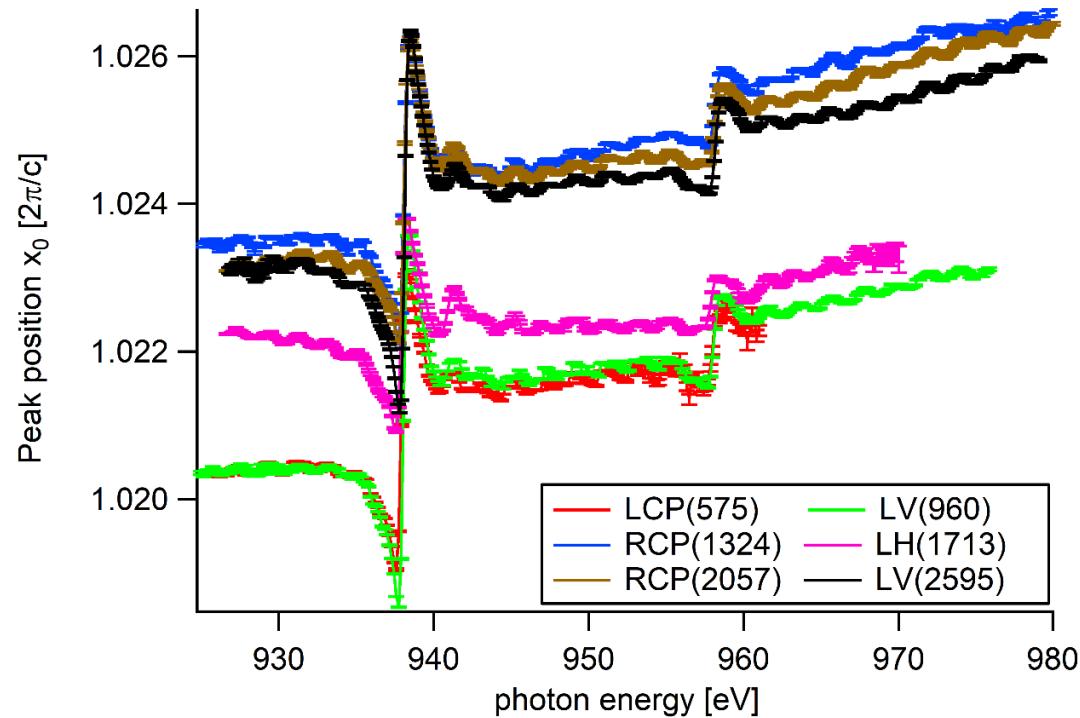
CALCULATED χ^2 FOR VARIOUS POLARIZATIONS

One directly notice that, the first 4 datasets has the minimum value with similiar energy offset, but the last ones have totally different offsets. It might be caused by the change of energy sampling for the last two polarizations from $dE = 0.15\text{eV}$ to $dE = 0.10\text{eV}$.

polarization	Offset ΔE [eV]	$\chi^2(\Delta E)$
LCP(575)	8.33 ± 0.15	0.6247
LV(960)	8.48 ± 0.15	1.4921
RCP(1324)	8.48 ± 0.15	0.8338
LH(1713)	8.18 ± 0.15	0.3984
RCP(2057)	1.00 ± 0.10	0.4927
LV(2595)	1.09 ± 0.10	0.9376



RESULTS



The oscillating is still present in the data, but it decreased.



V. Extracting physical quantities form the data

- 1. Complex refractive index**
- 2. Something else**



COMPLEX REFRACTIVE INDEX

The main goal in this experiment was to find the complex refractive index. In regular optical measurements one can obtain either the real part (diffraction, reflection experiments) or the imaginary part (absorption measurements). The RSXS can measure the whole complex refractive index as shown by Seve [2]. In this paper Seve establishes the formula for the real part of the refractive index:

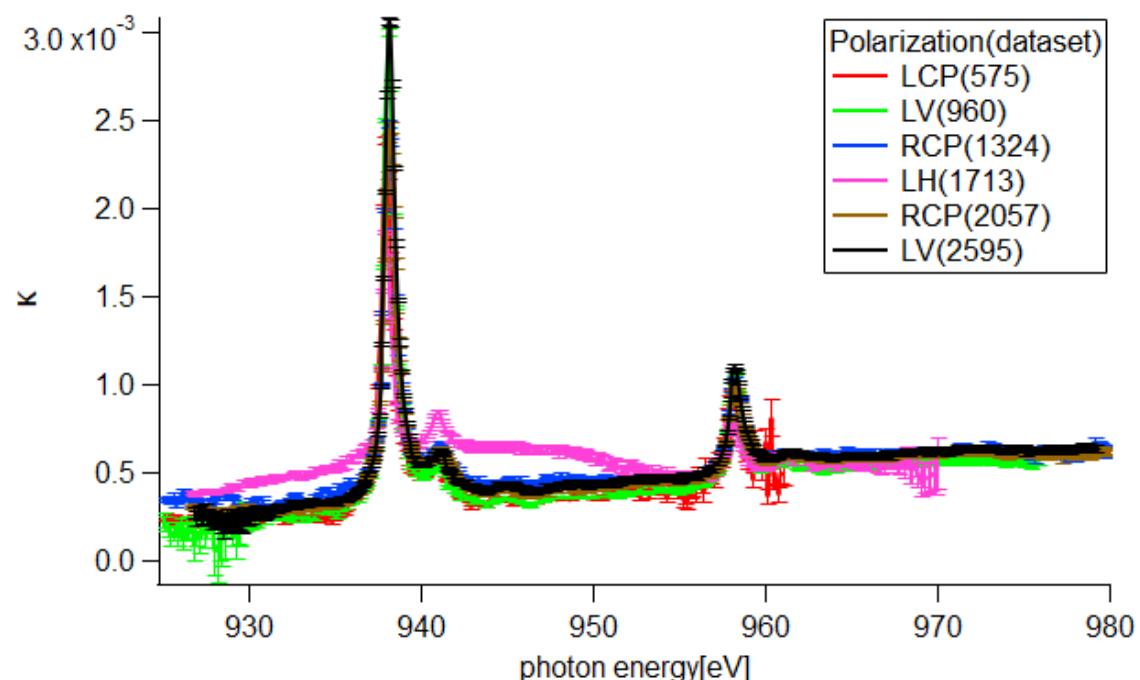
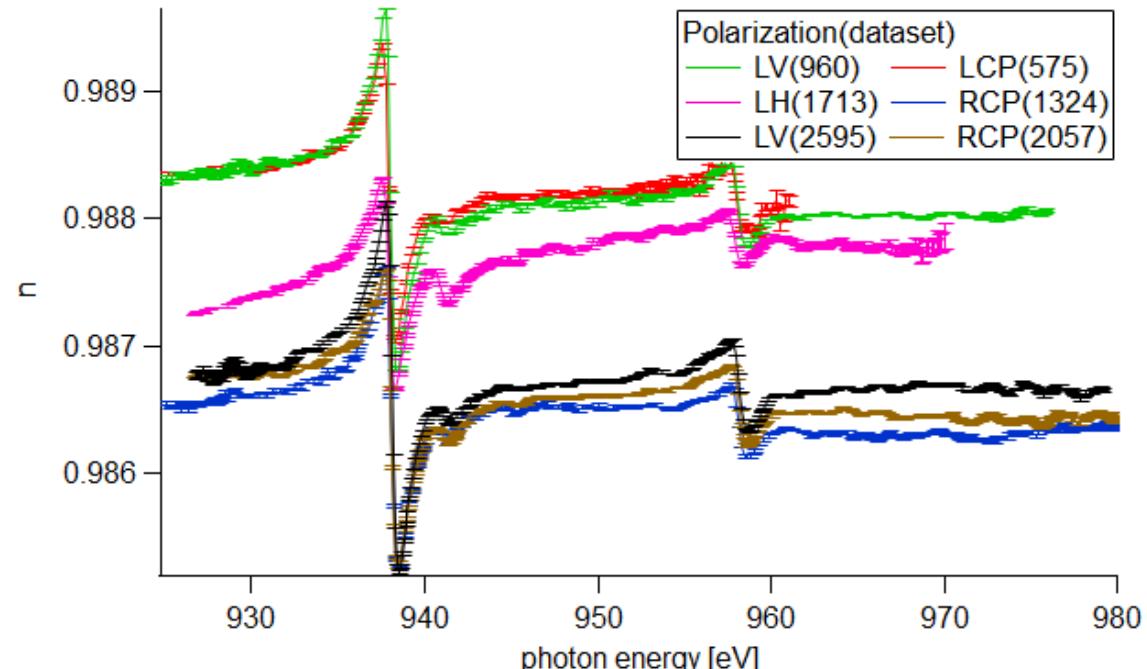
$$n(E) = 1 + \frac{1}{8} \left(\frac{hc}{2dE} \right)^2 - \frac{1}{2} \sin^2 \theta_B$$

with d being the lattice constant in the [001] direction; and for the linear absorption coefficient as $\mu(E) = \frac{1}{2} FWHM \cdot \sin \theta_B$, where θ_B is the scattering angle, which can be determined from the momentum transfer, which leads to $\theta_B(E) = \arcsin \left(\frac{hc}{2dE} x_0(E) \right)$, where we used $x_0 = \frac{d}{2\pi} q = \frac{d}{\lambda}$. The imaginary part of the refractive index can be then directly obtained from the absorption coefficient by the formula $\mu = \frac{2\omega\kappa}{c}$, which yields the general formula in terms of fit parameters:

$$\kappa(E) = \left(\frac{hc}{2dE} \right)^2 \cdot \sqrt{B} \cdot x_0(E)$$

For both quantities the standard error was calculated by the general formula:

$$\sigma[f(x_1, \dots, x_n)] = \sqrt{\sum_i \left[\frac{\partial f}{\partial x_i} \sigma(x_i) \right]^2}$$



- VI. Kramers-Kronig Analysis
 - 1. Regular Kramers-Kronig transform (KKT) and its inverse (IKKT)
 - 2. Extended KKT and IKKT
 - 3. KKT for all polarizations
 - 4. Conclusions



REGULAR KRAMERS-KRONIG AND IST INVERSE

The main problem in using the Kramers-Kronig transform (KKT) for optical quantities is the small range of the available experimental data. One needs to perform the measurement over the whole (infinnit) frequency range, which is impossible. The general KKT for a response function $G(\omega)$ are defined as [3]:

$$Re[G(\omega)] = \frac{1}{\pi} \int_0^{\infty} \frac{Im[G(\omega)]dE'}{\omega - \omega'}$$

$$Im[G(\omega)] = -\frac{1}{\pi} \int_0^{\infty} \frac{Re[G(\omega)]}{\omega - \omega'} dE'$$

The KKT for the real and imaginary part of the refractive index are as follows [3] (with substituting $E = \hbar\omega$):

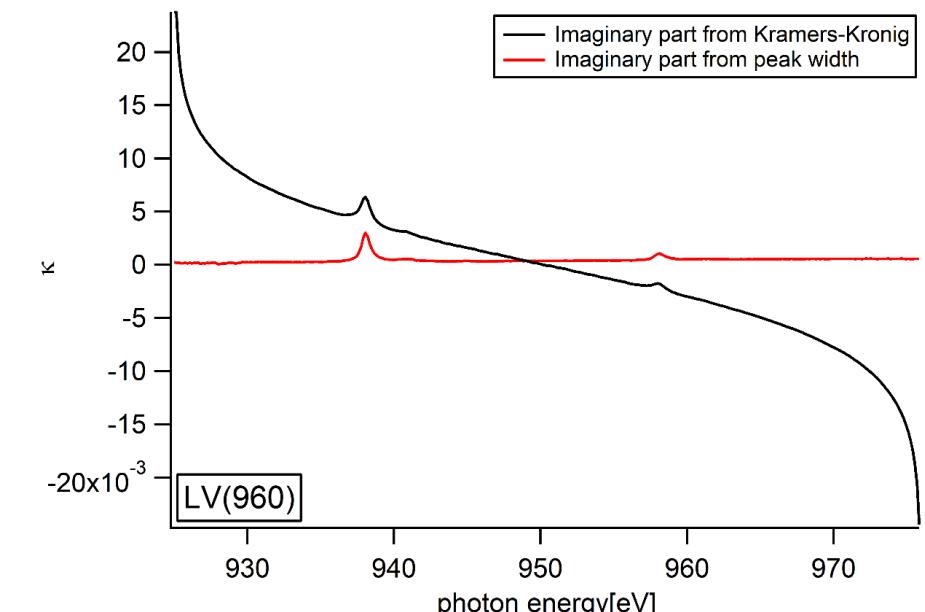
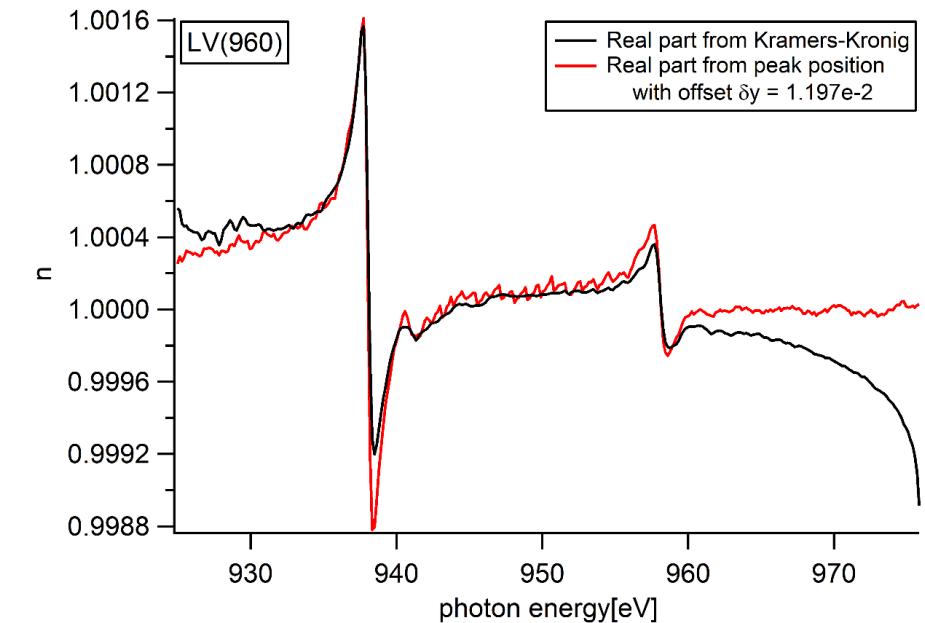
$$n(E) = 1 + \frac{2}{\pi} \int_0^{\infty} \frac{E' \kappa(E') dE'}{E^2 - E'^2}$$

$$\kappa(E) = -\frac{2E}{\pi} \int_0^{\infty} \frac{n(E') - 1}{E^2 - E'^2} dE'$$

Performing the integration over the measured energy range does not give correct results. On the right side we can see comparison of real data and their KKT as stated above and the imaginary data with its inverse KKT (IKKT) companion .

Both transformation shows strong deviation at the range edges (called „edge effects“), which is caused by the lack of measured data (discontinuity of the curve at the edges). The IKKT is clearly not applicable as long as one has a small frequency (energy) range. On the other hand the KKT shows similiar behaviour, but has replicated the main features of the real part of the optical index. This means one could use the KKT only to have a look at the behaviour of the given quantity (mainly at the resonances).

In the later slide a solution to this boundary problem is described and other solution in recent publications are mentioned.



EXTENDED KKT AND IKKT

The first solution (which is actually used in the analysis of the refractive index) is to fit the experimental data at the energy ranges and to extrapolate the data with the fit function with a continuity constraint of the data at the ends of the measurement range, mathematically defined as:

$$\lim_{E \rightarrow E_0^-} f_{\text{extended}}(E) = \lim_{E \rightarrow E_0^+} f_{\text{exp}}(E)$$

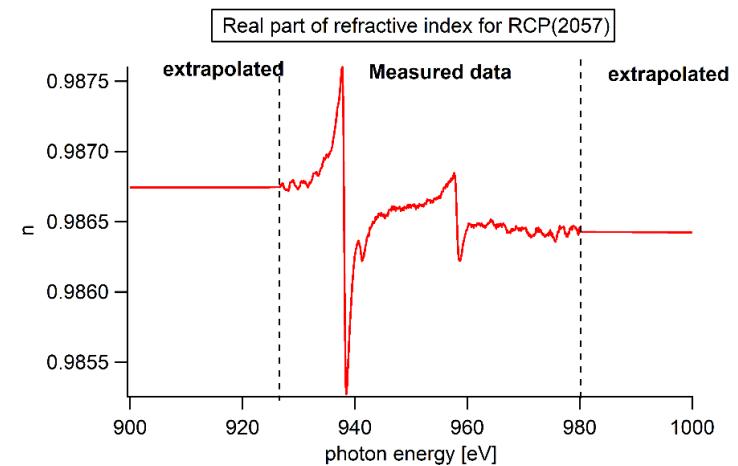
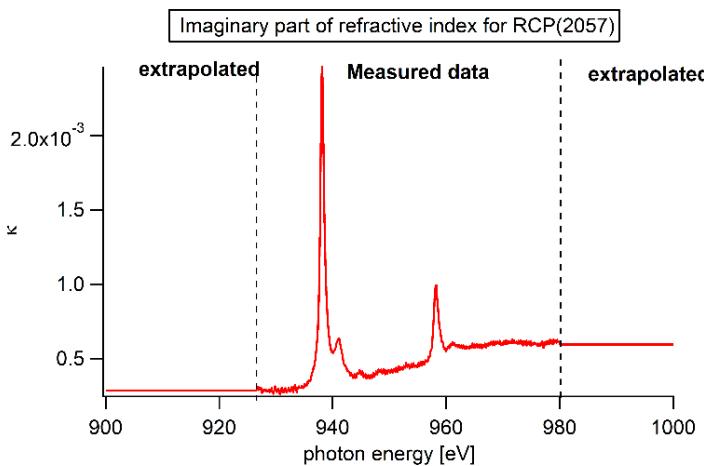
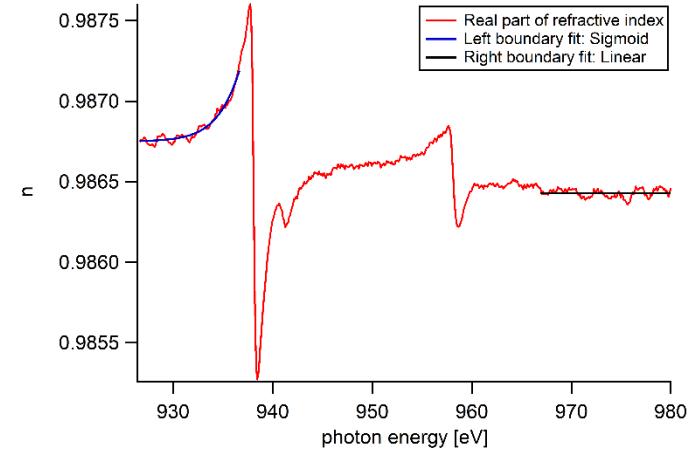
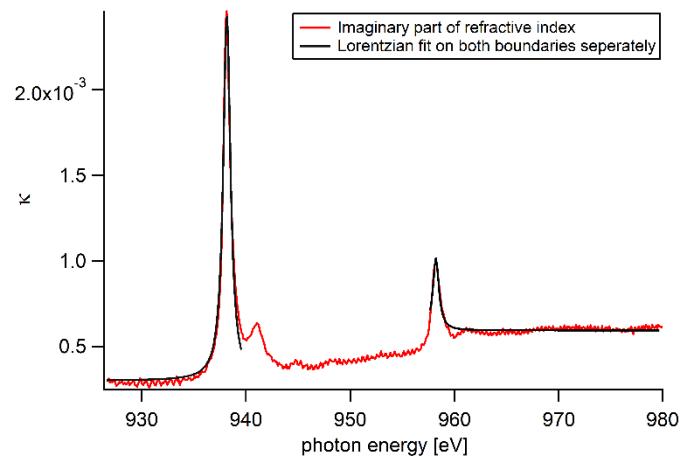
$$\lim_{E \rightarrow E_{\text{end}}^-} f_{\text{extended}}(E) = \lim_{E \rightarrow E_{\text{end}}^+} f_{\text{exp}}(E)$$

No assumption were made for the data at infinite frequency, only at the range boarders. The graphs on the right side show the fit procedure for the refractive index and the extrapolated data (the data is extrapolated to a larger energy range, but for presenting the extrapolating process it was cut to a smaller region).

This KKT extending scheme give reasonable results which are shown in the next slide. There exist other solutions to this problem, such as:

- Using Fourier Transform analysis [4]
 - A relation for the Kramers-Kronig with the Fourier-Series coefficient is derived in this paper. Knowing those coefficients yields directly to the KK transformed curve. This method reduces the edge effect, but didn't get rid of it.
- Using a simple lorentzian curve beyond the measured region [5]
 - This methods is applicable for each resonance peak separately, but for a broader spectrum of resonances it the KKT don't match the proper result.

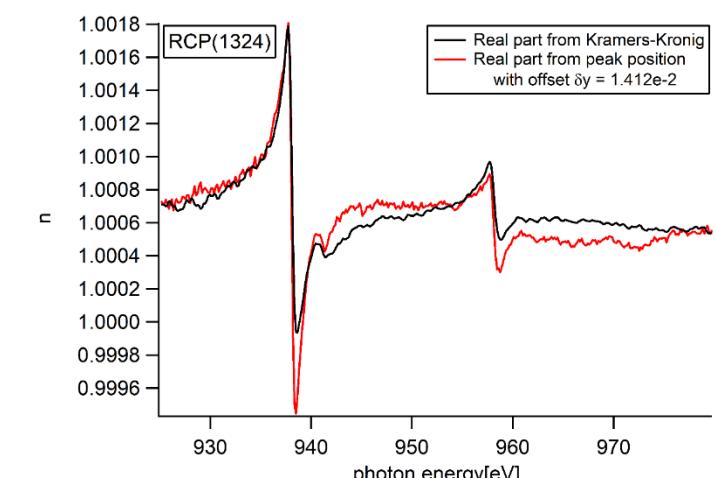
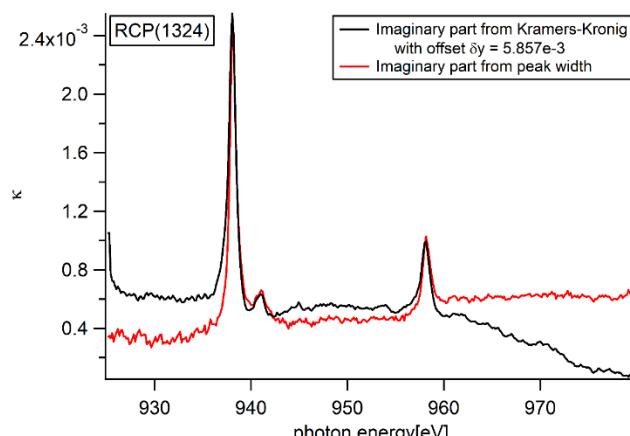
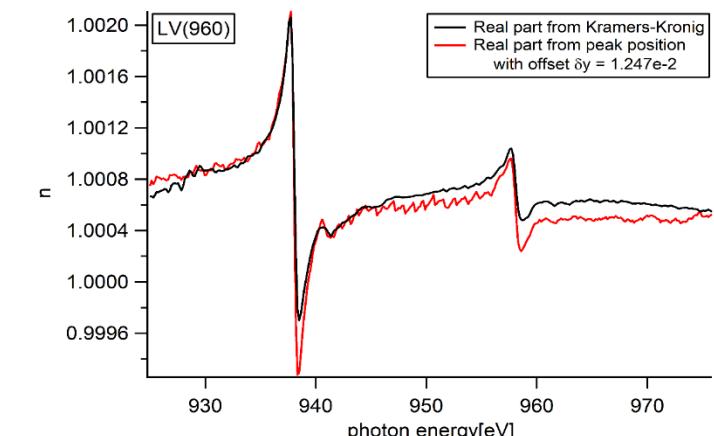
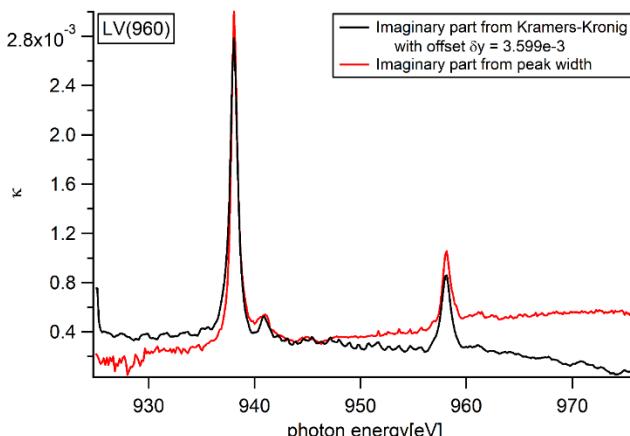
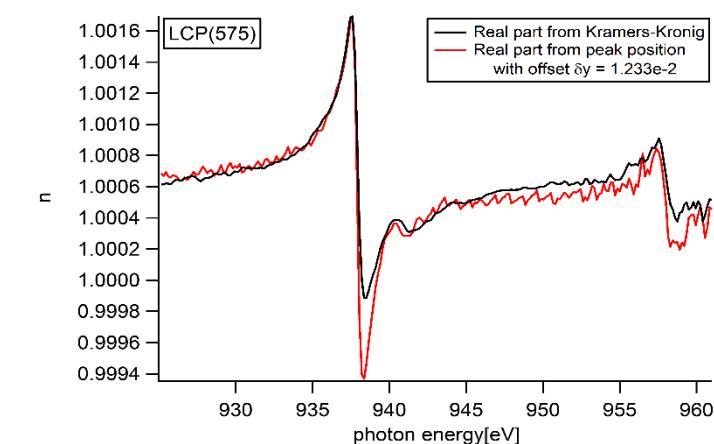
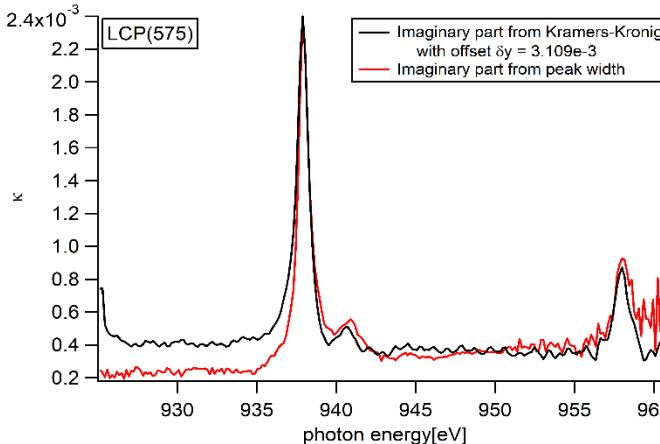
For a multi-resonant peak the method we applied shows the best results.



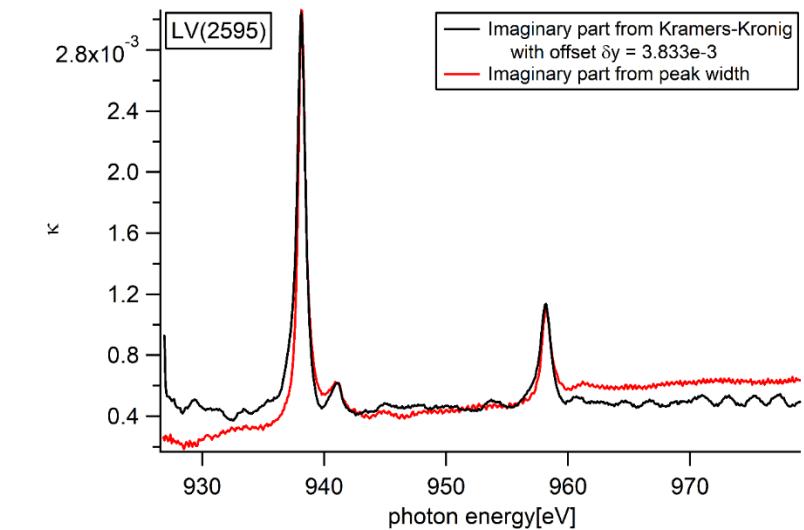
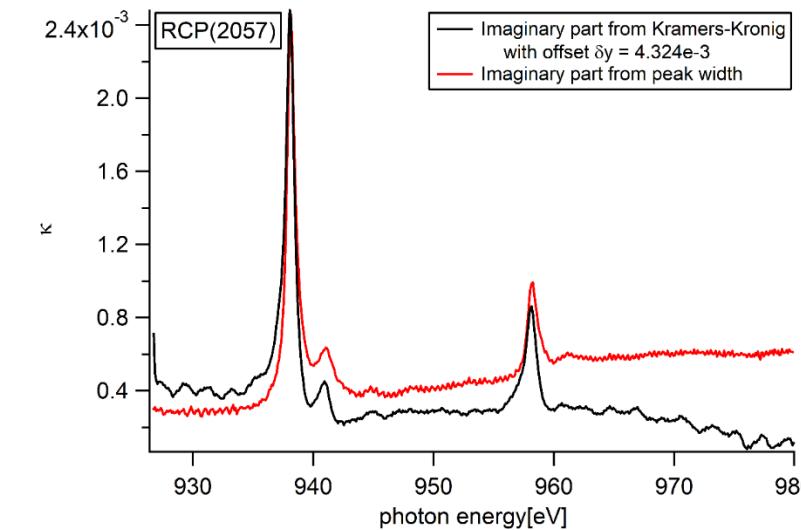
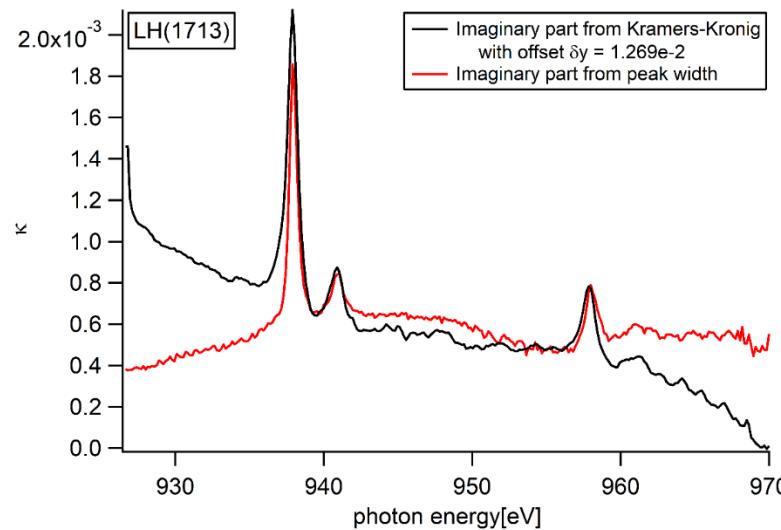
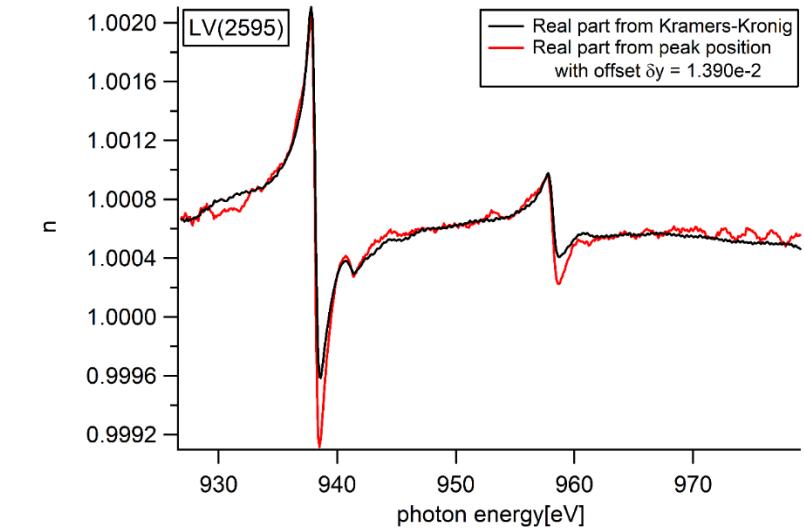
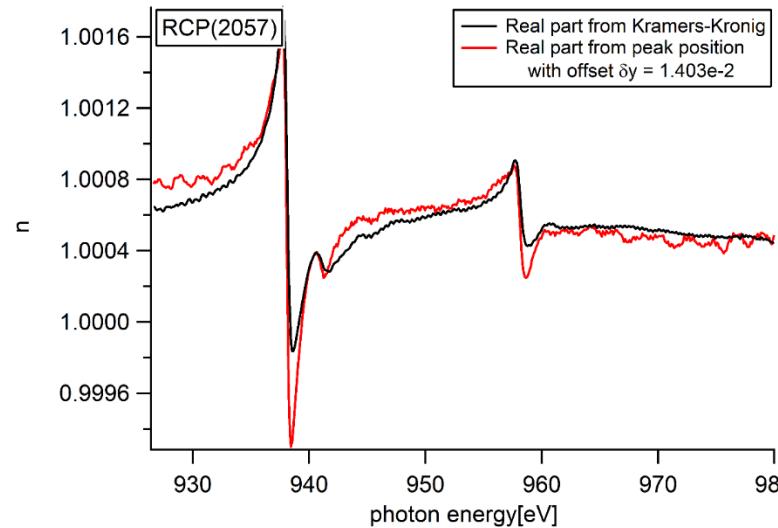
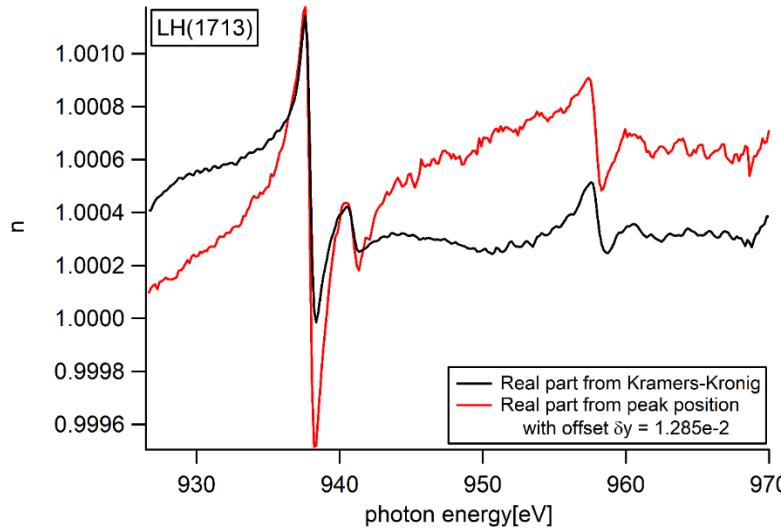
KKT FOR ALL POLARIZATIONS

What we see in these graphs and the one in the later slide is the KKT and IKKT applied for the experimental data for each polarization. For the KKT almost every dataset matches the experimental data (only a constant y-offset had to be applied). Although for LH polarization the KKT doesn't fit the experimental data.

In contrast the IKKT decreases with energy, which can be explained by the fact, that the refractive index lies below unity. In general the real part of the refractive index should be in the large frequency limit equal to unity. This deviation of the refractive index is caused by the deviation in the peak position from unity.



KKT FOR ALL POLARIZATIONS



CONCLUSIONS

TO DO:

- Stichpunkte, nicht text
- Title, graph bigger
- make comparison for IKKT if the energy range changes the edge effect



- VII. Total Electron Yield
 - 1. Raw data
 - 2. Fitting background
 - 3. Multipeak fit for finding resonances.
 - 4. Resonance frequencies

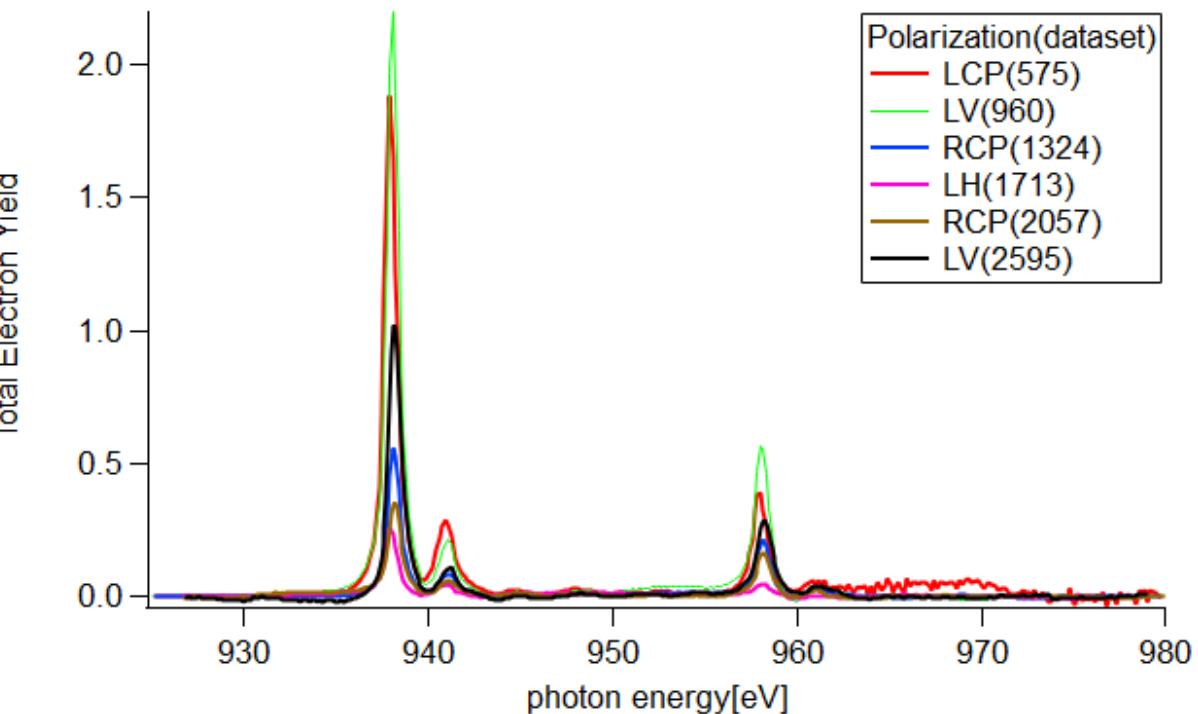
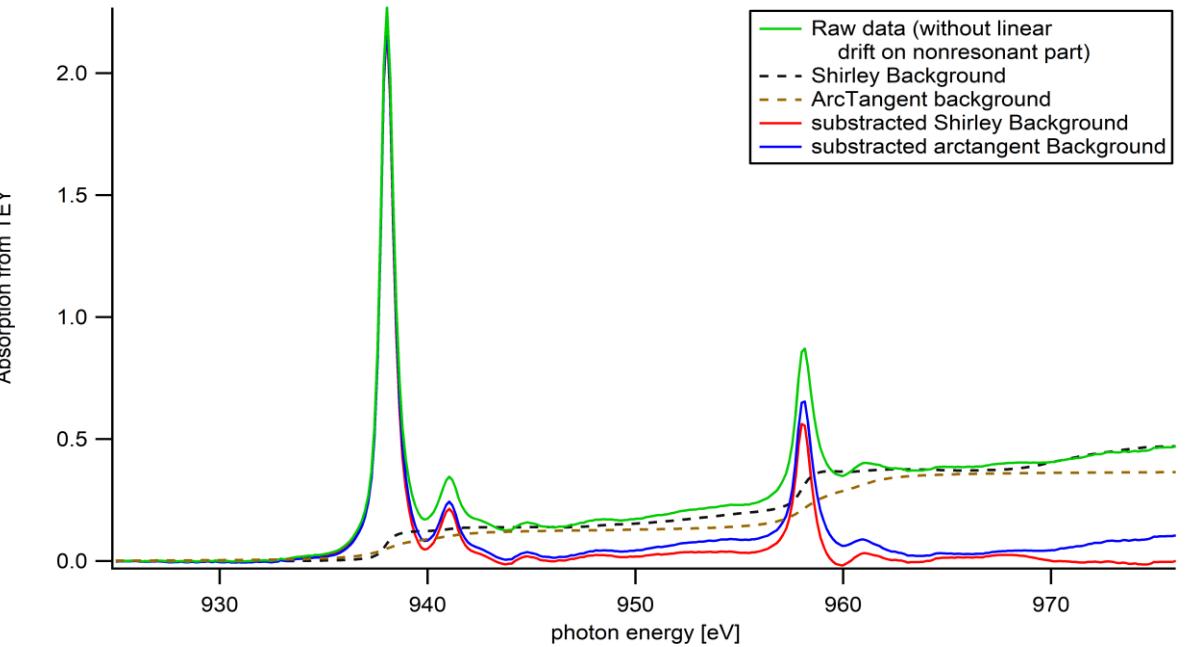


RAW TEY DATA

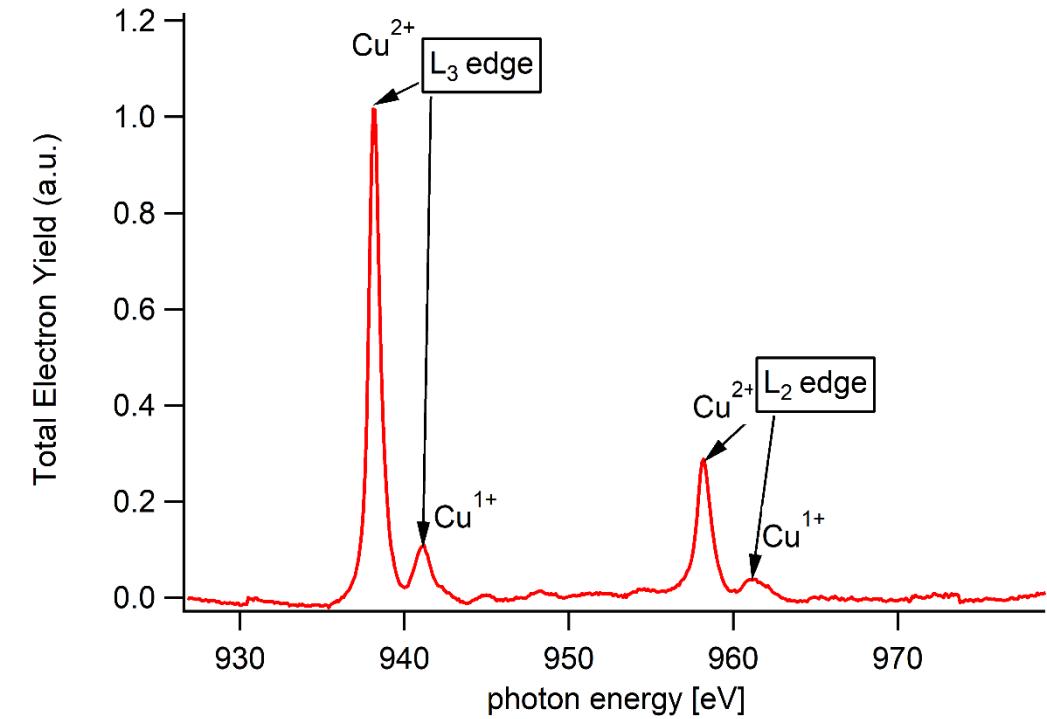
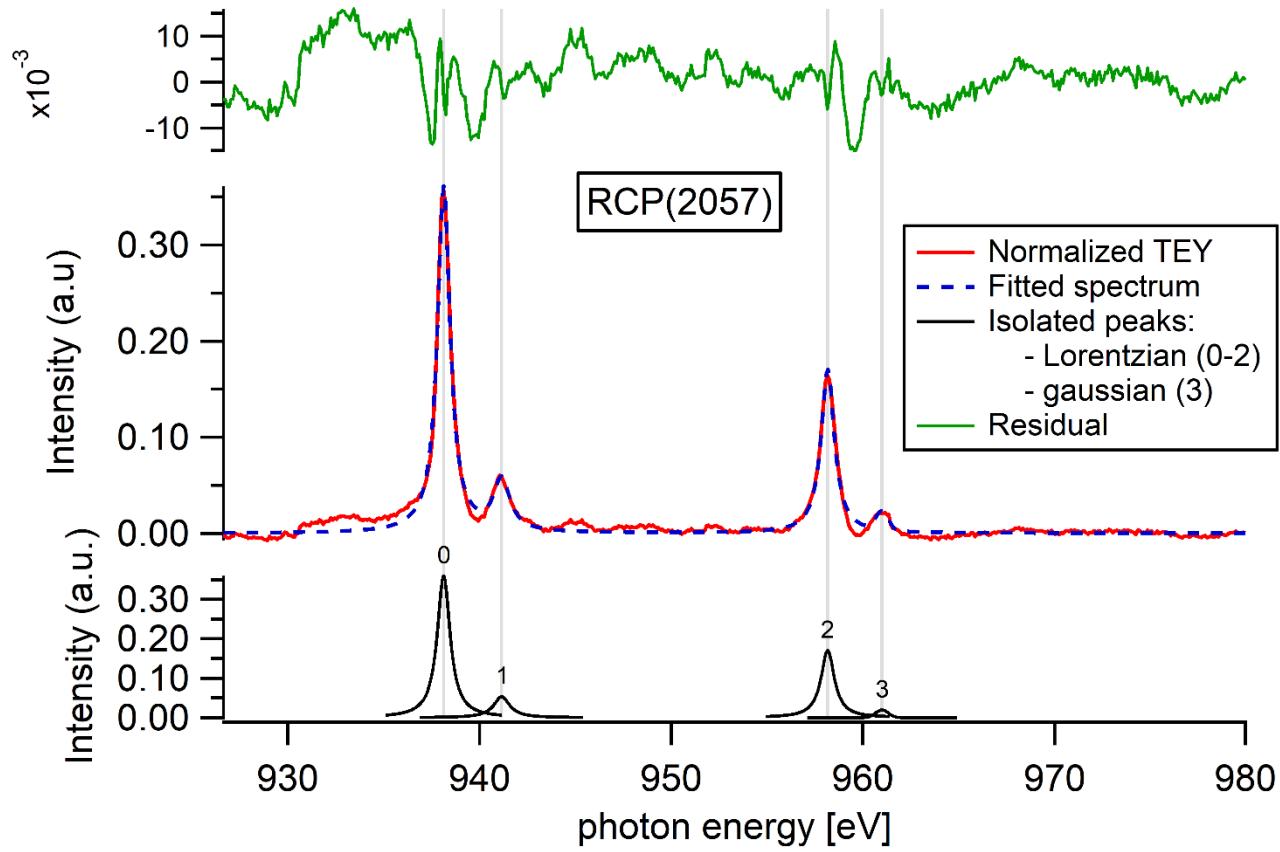


FITING BACKGROUND

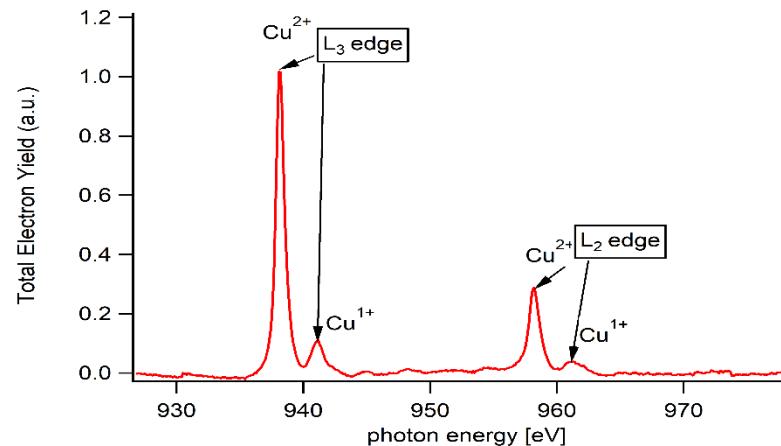
A common procedure in analyzing X-ray Absorption Spectra is to determine the background intensity associated with excitation of electrons into the continuum. One could use various methods to evaluate the background (which is very similar to a step function). The upper graph shows 2 different ways to do so. One is using the Shirley algorithm and the other is using the arcus tangent function to fit into the background. Each gives reasonable results, but the first one is clearly fitting this feature.



MULTIPEAK FIT



RESONANCE FREQUENCIES



edge	$\text{Cu}^{2+} \text{ L}_3 \text{ edge}$			$\text{Cu}^{1+} \text{ L}_3 \text{ edge}$			$\text{Cu}^{2+} \text{ L}_2 \text{ edge}$			$\text{Cu}^{1+} \text{ L}_2 \text{ edge}$		
Polarization	E_0 [eV]	FWHM [eV]	ΔE_0	E_0 [eV]	FWHM [eV]	ΔE_0	E_0 [eV]	FWHM [eV]	ΔE_0	E_0 [eV]	FWHM [eV]	
LCP	937.92	0.69799	2.98	940.90	1.047	17.06	957.96	1.033	-	-	-	
LV(960)	938.05	0.70837	3.03	941.08	0.93292	16.98	958.06	1.0434	3.12	961.18	0.98713	
RCP(1324)	938.11	0.7116	3.01	941.12	1.0446	17.00	958.12	1.0286	3.08	961.20	1.2238	
LH	937.94	0.76062	2.99	940.93	0.97119	17.14	958.07	1.2016	-	-	-	
RCP(2057)	938.15	0.80463	2.90	941.05	1.102	17.10	958.15	1.0462	3.00	961.15	0.85475	
LV(2595)	938.17	0.70723	2.99	941.16	1.0607	17.05	958.21	1.0194	3.22	961.43	1.5048	

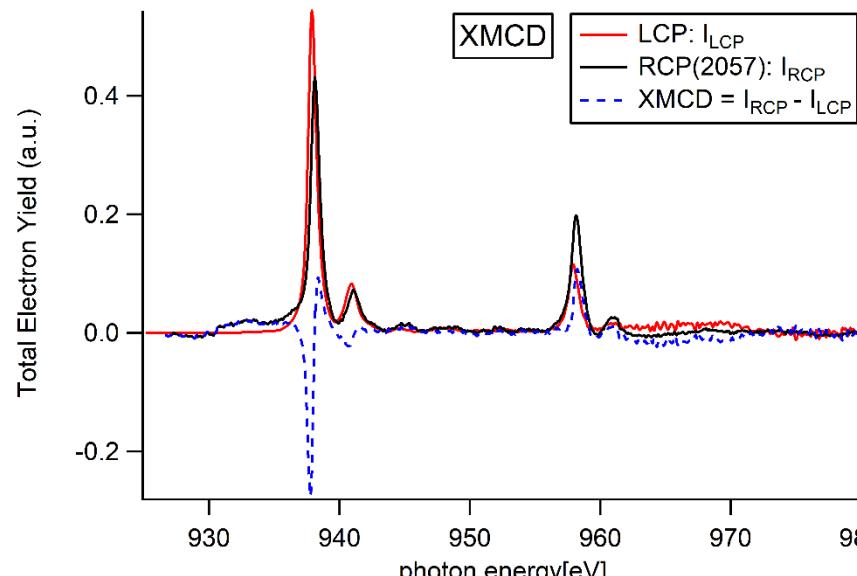
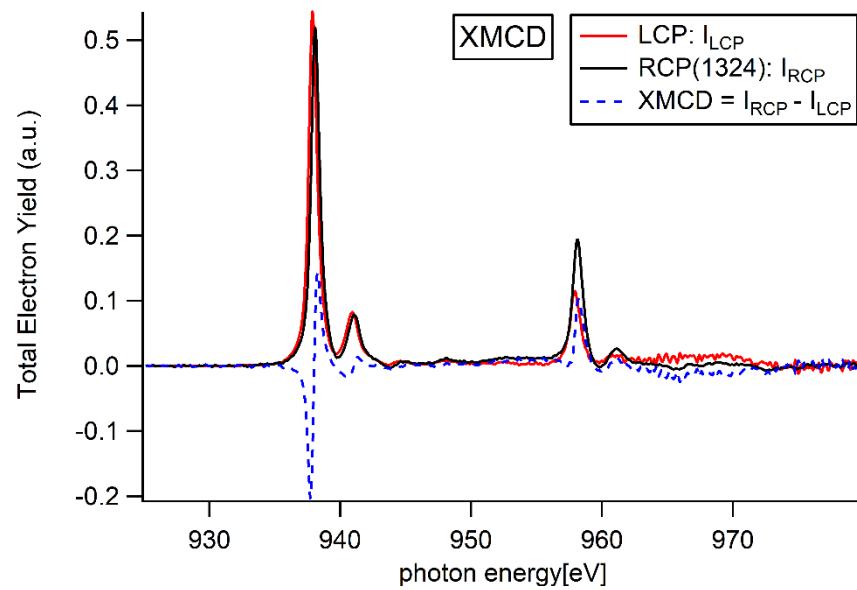


- **VIII. Magnetic Dichroism**
 - 1. Circular Magnetic Dichroism
 - 2. Linear Magnetic Dichroism
 - 3. Magnetic Ordering: proper guess

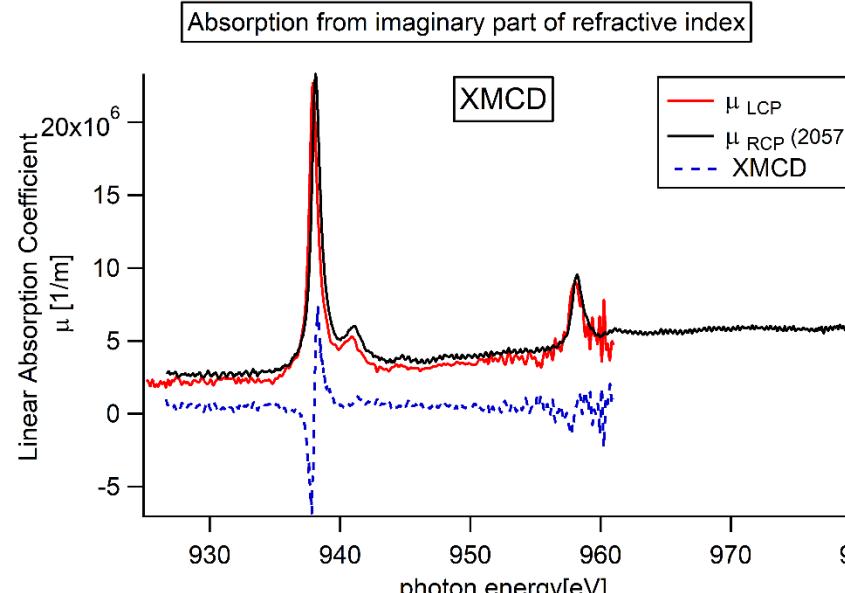
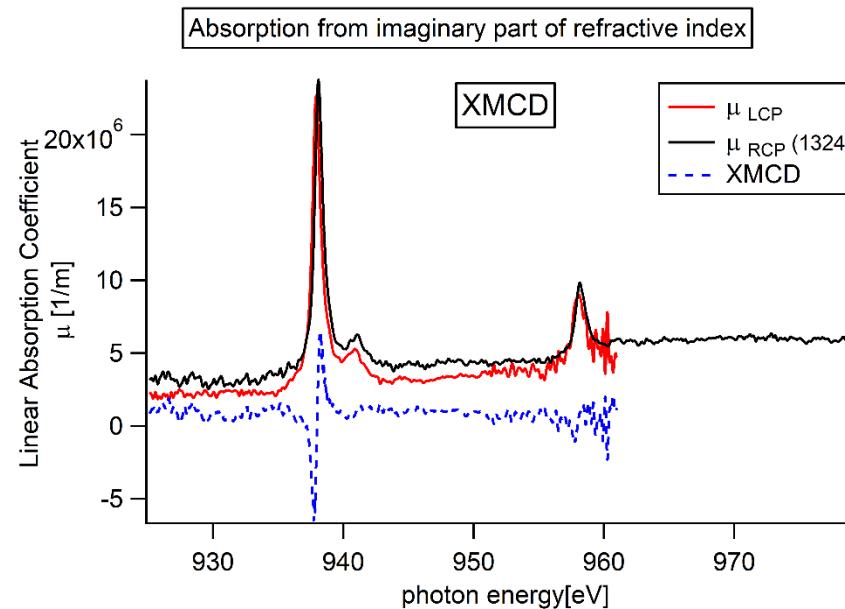


CIRCULAR MAGNETIC X-RAY DICHROISM (CMXD)

From TEY

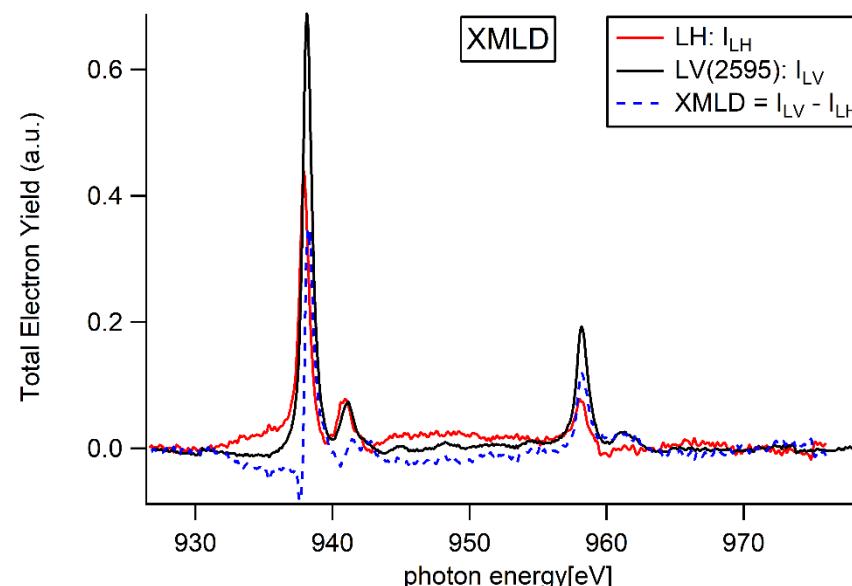
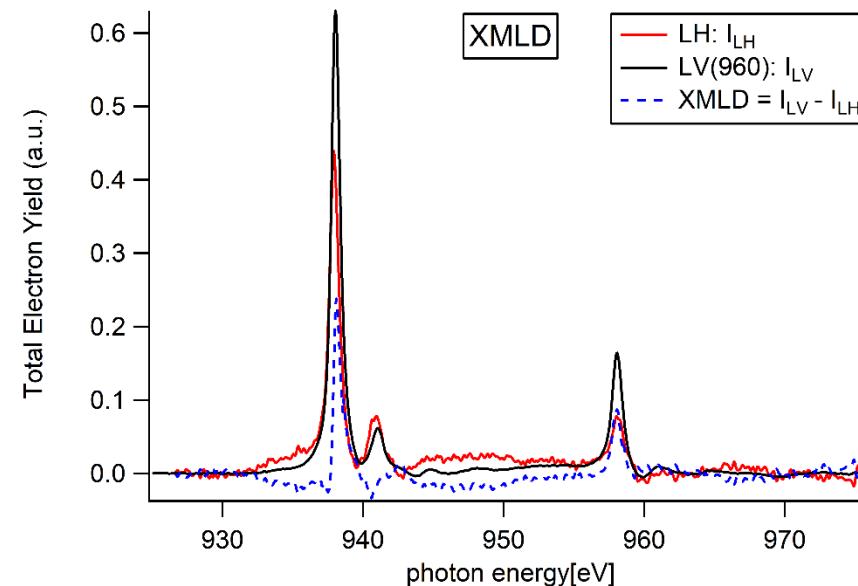


From Imaginary part of refractive index

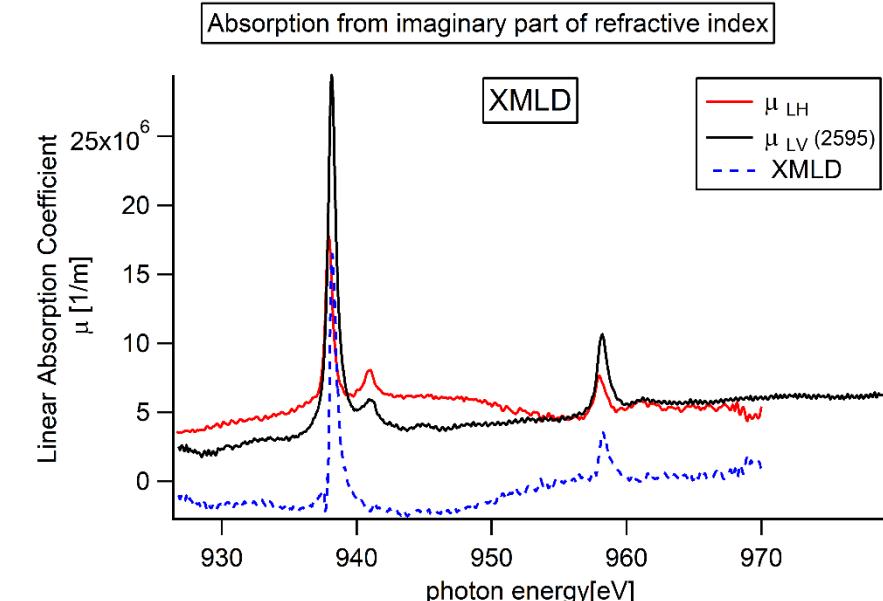
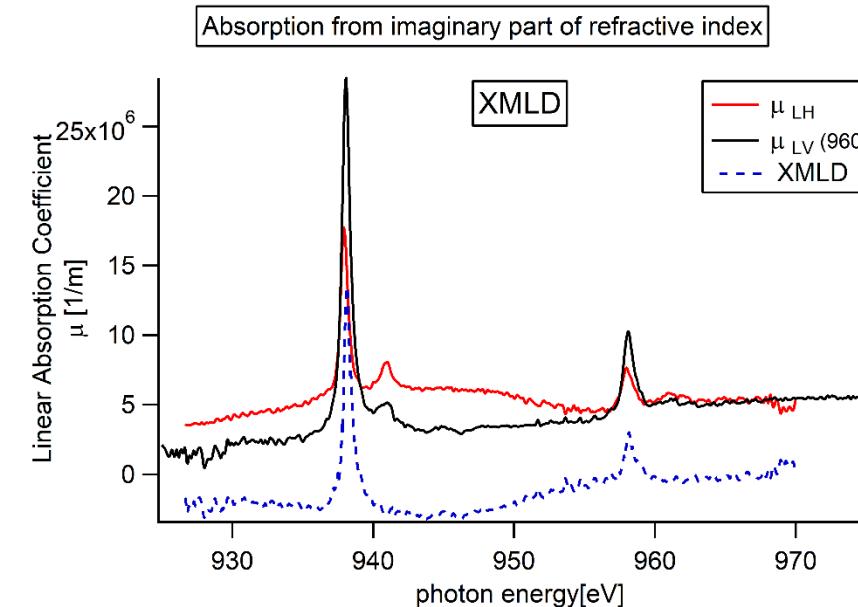


CIRCULAR MAGNETIC X-RAY DICHROISM (LMD)

From TEY



From Imaginary part of refractive index



MAGNETIC ORDERING

- Strong circular dichroic effects suggest rather ferromagnetic ordering
- Linear dichroic effect result from the lattice structure (tetragonal symmetry)
- The investigated material is a cuprate, thus it is a spin-half system and in the most cases exhibits antiferromagnetic ordering



OPTICAL CONDUCTIVITY

The measurement of X-ray absorption intensities is giving various application in analyzing magnetic materials. According to Haverkord [3] one could extract the conductivity tensor knowing the absorption for different polarizations. For a magnetic material one needs to determine the off-diagonal elements of the tensor, which can be done using circular polarized light.

Among the transition metals, copper (Cu), is a common spin-1/2 system. That means we can neglect bimagnon excitation (which are typically very weak) and write the conductivity tensor in the form:

$$\vec{\sigma} = \begin{pmatrix} \sigma_{a_{1g}}^{(0)} & 2S_z\sigma_{a_{2u}}^{(1)} & -2S_y\sigma_{e_u}^{(1)} \\ -2S_z\sigma_{a_{2u}}^{(1)} & \sigma_{a_{1g}}^{(0)} & 2S_x\sigma_{e_u}^{(1)} \\ 2S_y\sigma_{e_u}^{(1)} & -2S_x\sigma_{e_u}^{(1)} & \sigma_{a_{1g}}^{(0)} \end{pmatrix} \quad (1)$$

Neglecting self-absorption effects the absorption from XAS is directly proportional to the conductivity tensor:

$$I_{TEY} = -\text{Im}(\epsilon^* \cdot \vec{\sigma} \cdot \epsilon)$$

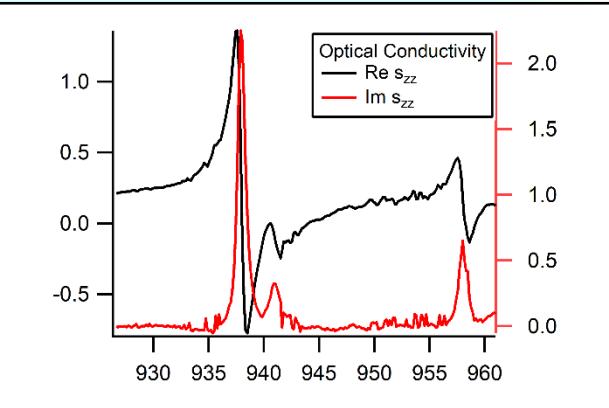
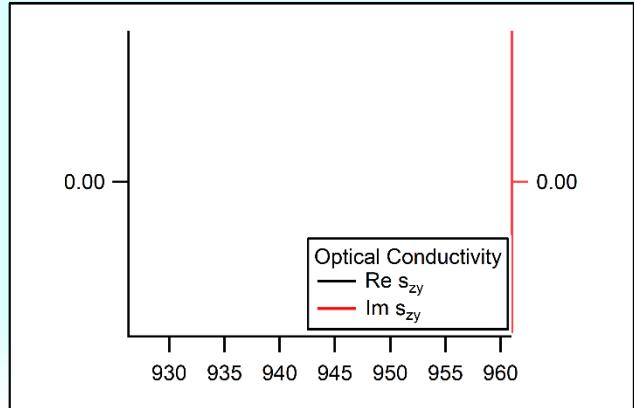
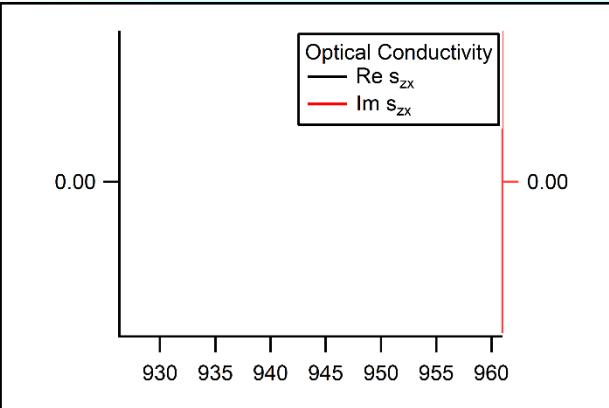
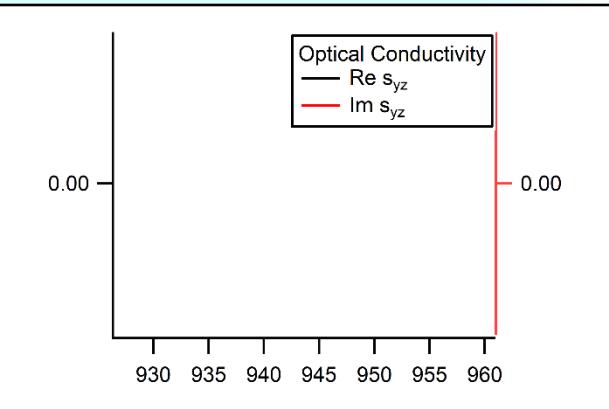
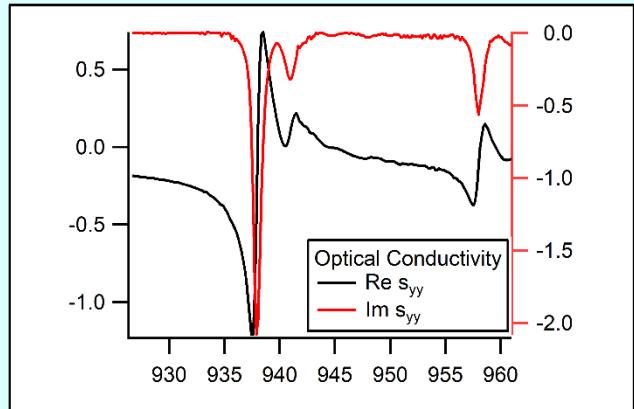
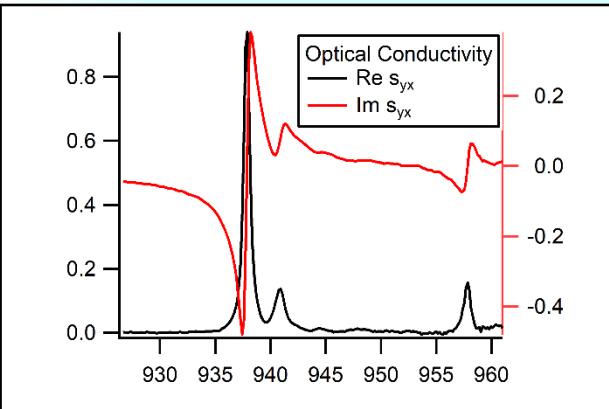
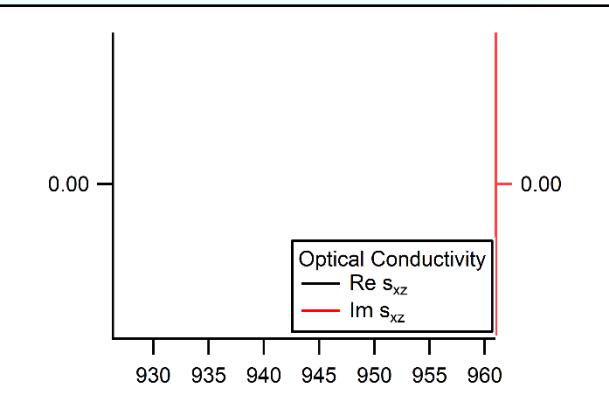
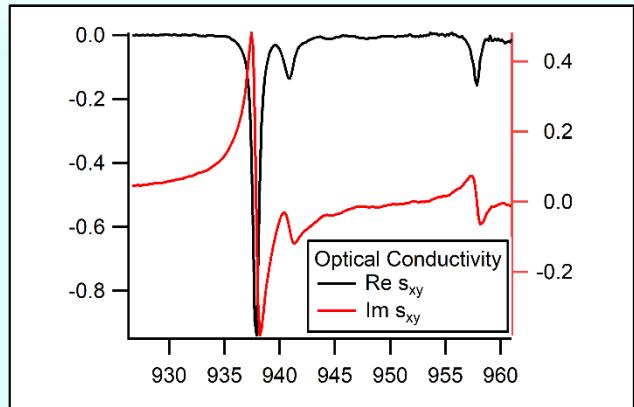
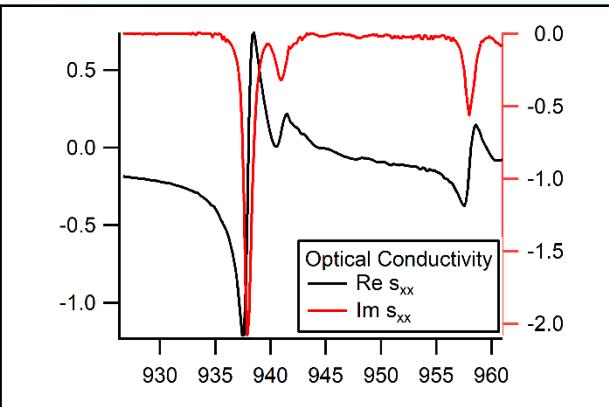
Using these two relations one can evaluate each of the tensor elements in (1)

This method yields only the imaginary part of the diagonal elements and the real part of the off-diagonal elements. As these are spectra function (in general response functions) one can use the KKT to get the imaginary/real companion.



OPTICAL CONDUCTIVITY

Optical Conductivity Tensor from TEY



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- [2] „*Determination of the Anomalous Scattering Factors in the Soft-X-ray Range using Diffraction from a Multilayer*“, L. Seve, J. M. Tonnerre and D. Raoux
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RSXS RESULT

